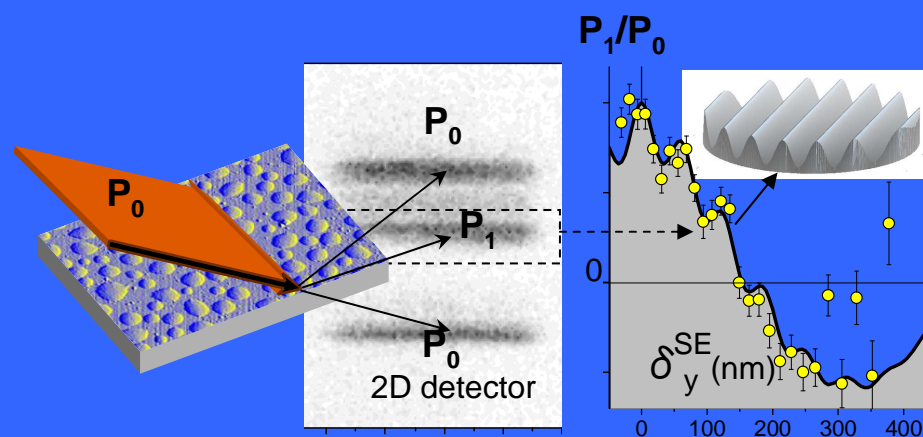


SPIN-ECHO CODING OF THE MOMENTUM TRANSFER IN GRAZING INCIDENCE SCATTERING

Alexei Vorobiev
ESRF



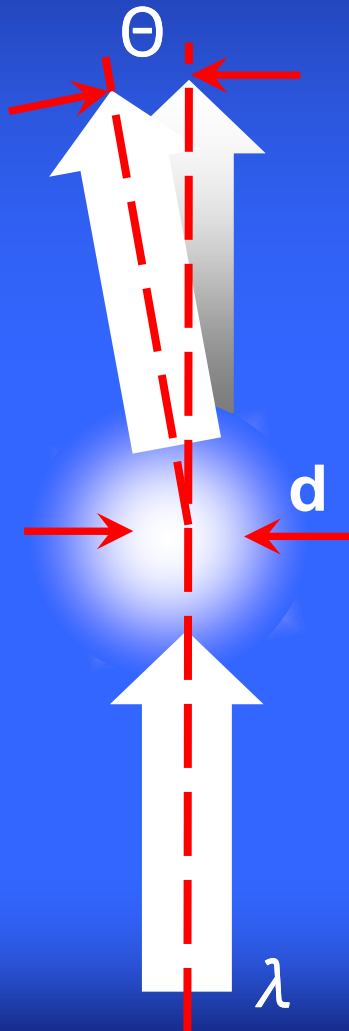
FORMULATION OF THE PROBLEM

Neutron scattering uses Bragg's law to measure a distance d within the sample

$$\lambda = 2d \sin \Theta$$

if $d \ll \lambda \Rightarrow \Theta$ is small

- \Rightarrow to measure small Θ one has to collimate both incident and scattered beams
- \Rightarrow measured intensity will be very low
- \Rightarrow one should try to find a way to measure small angles without tightening of the beam



Proposed solution:

use spin-echo encoding of the momentum transfer

depolarization of the beam is measured instead of the scattering angle

no collimation of the neutron beam is need

structural information about the sample is obtained in real space

OUTLINE

- **Basic principles of neutron spin echo (SE).
Conventional SE for dynamic studies.**
- **SE angular coding for structural studies:
transmission mode – SESANS;
thick (3d) samples**
- **Experiments in reflection geometry: SERGIS
(Spin-Echo Resolved Grazing Incidence
Scattering);
ultra thin (2d) samples**

LARMOR PRECESSION

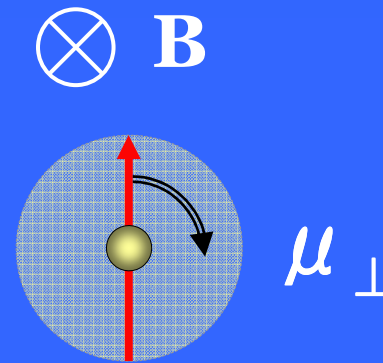
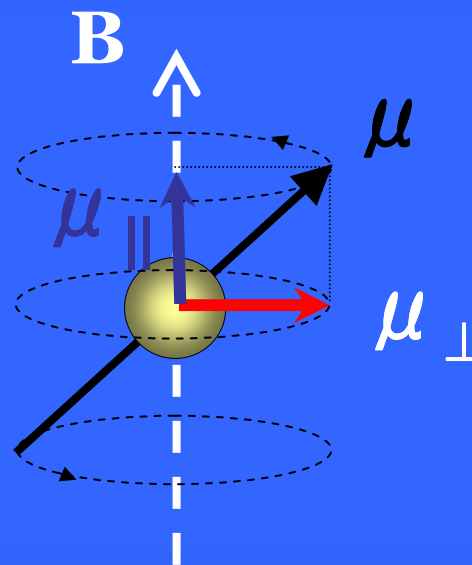
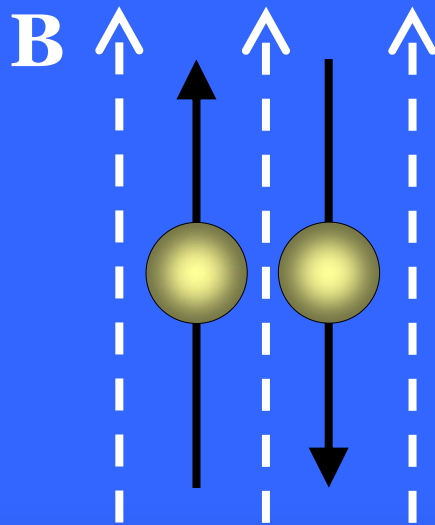
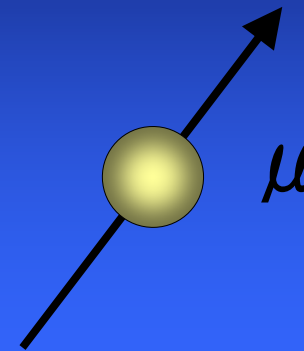
Neutron properties:

Mass $m=1.674928(1) \cdot 10^{-27}$ kg

Spin $s=\hbar/2$

Magnetic moment $\mu = -9.649 \cdot 10^{-27}$ JT⁻¹

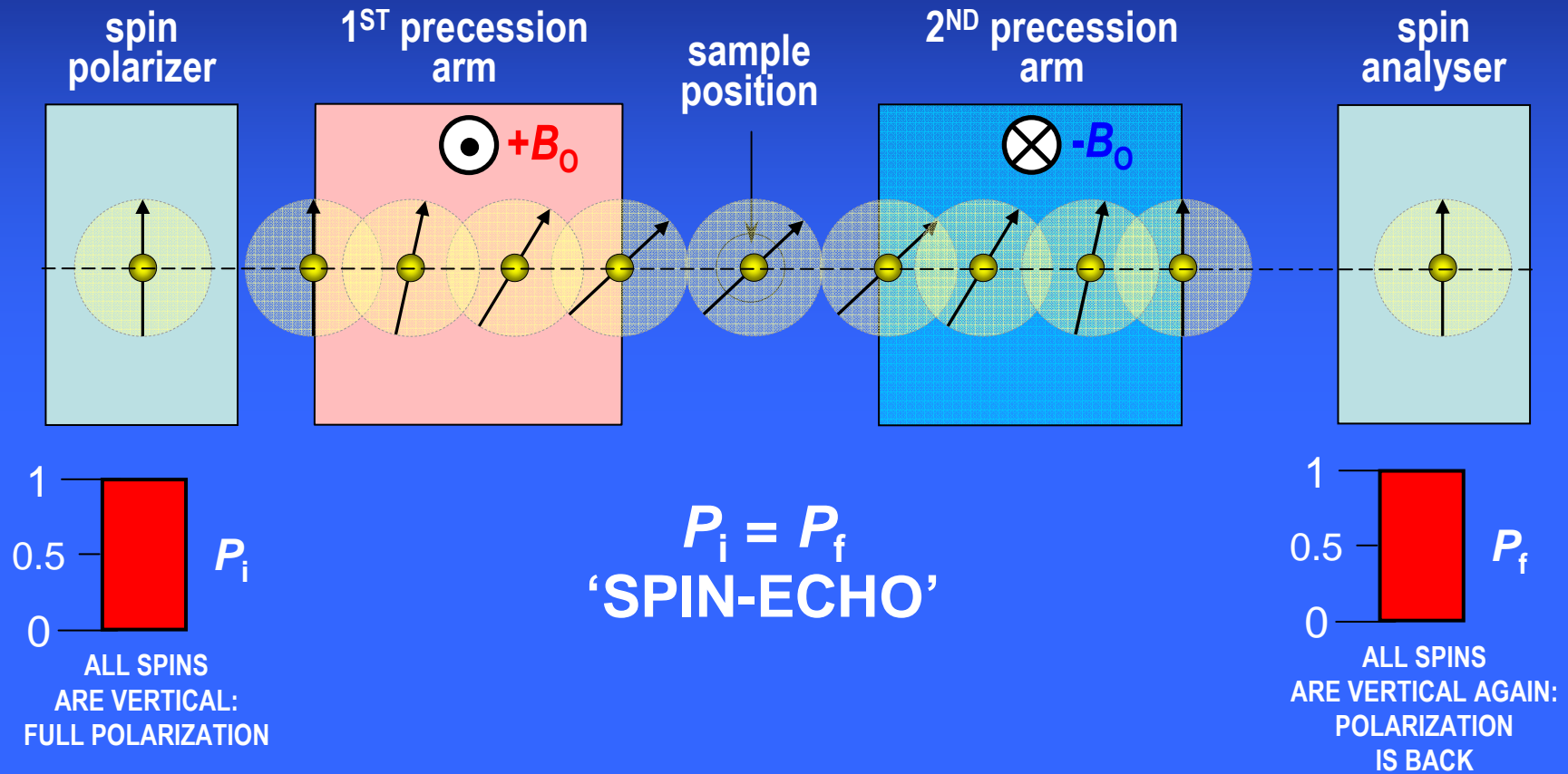
β -decay lifetime $\tau = 886$ s



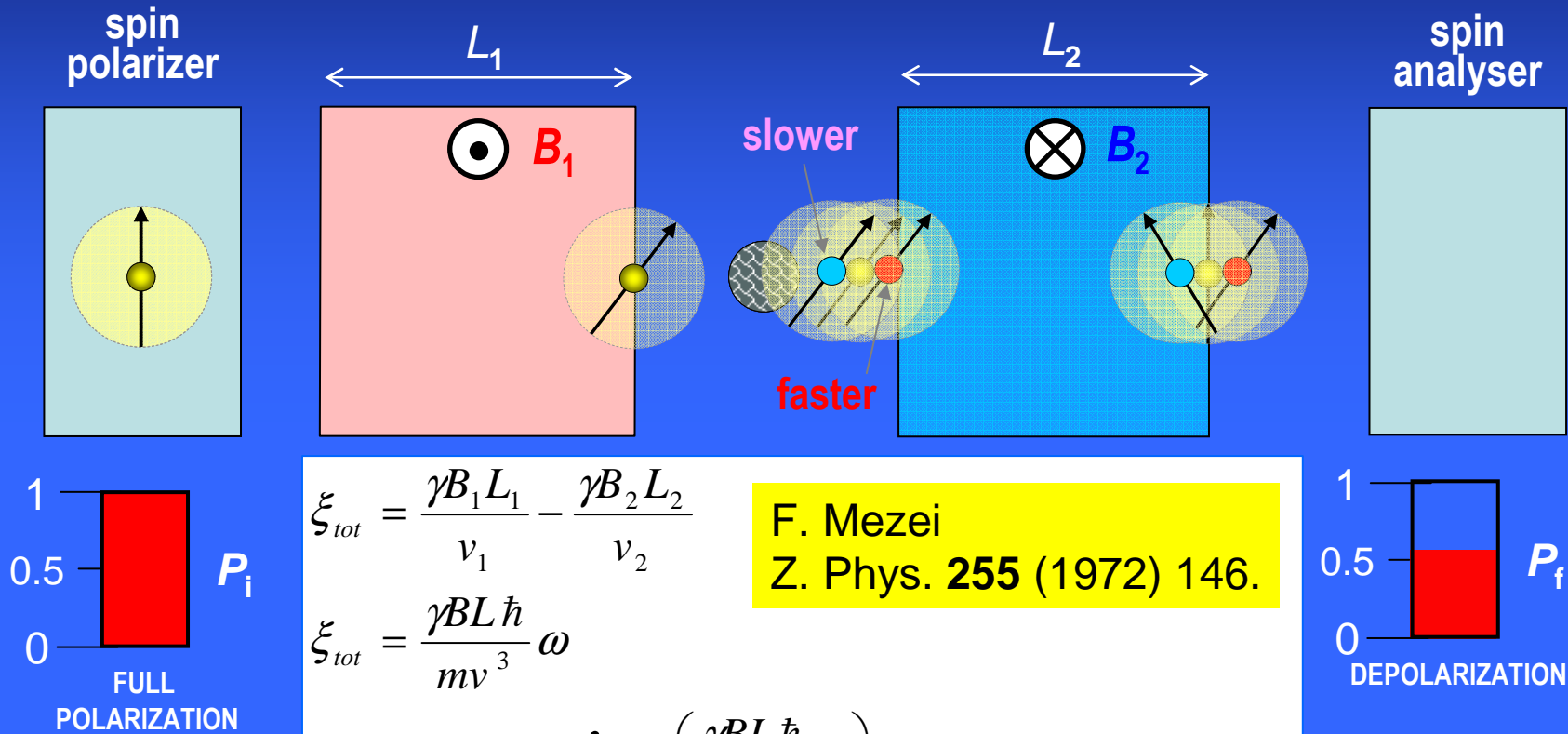
$$\omega = \gamma B$$

$$\gamma = 2917 \text{ Hz/Oe}$$

CONVENTIONAL SPIN-ECHO FOR DYNAMIC STUDY



INELASTIC SCATTERING



$\xi_{tot} = \frac{\gamma B_1 L_1}{v_1} - \frac{\gamma B_2 L_2}{v_2}$

$\xi_{tot} = \frac{\gamma B L \hbar}{m v^3} \omega$

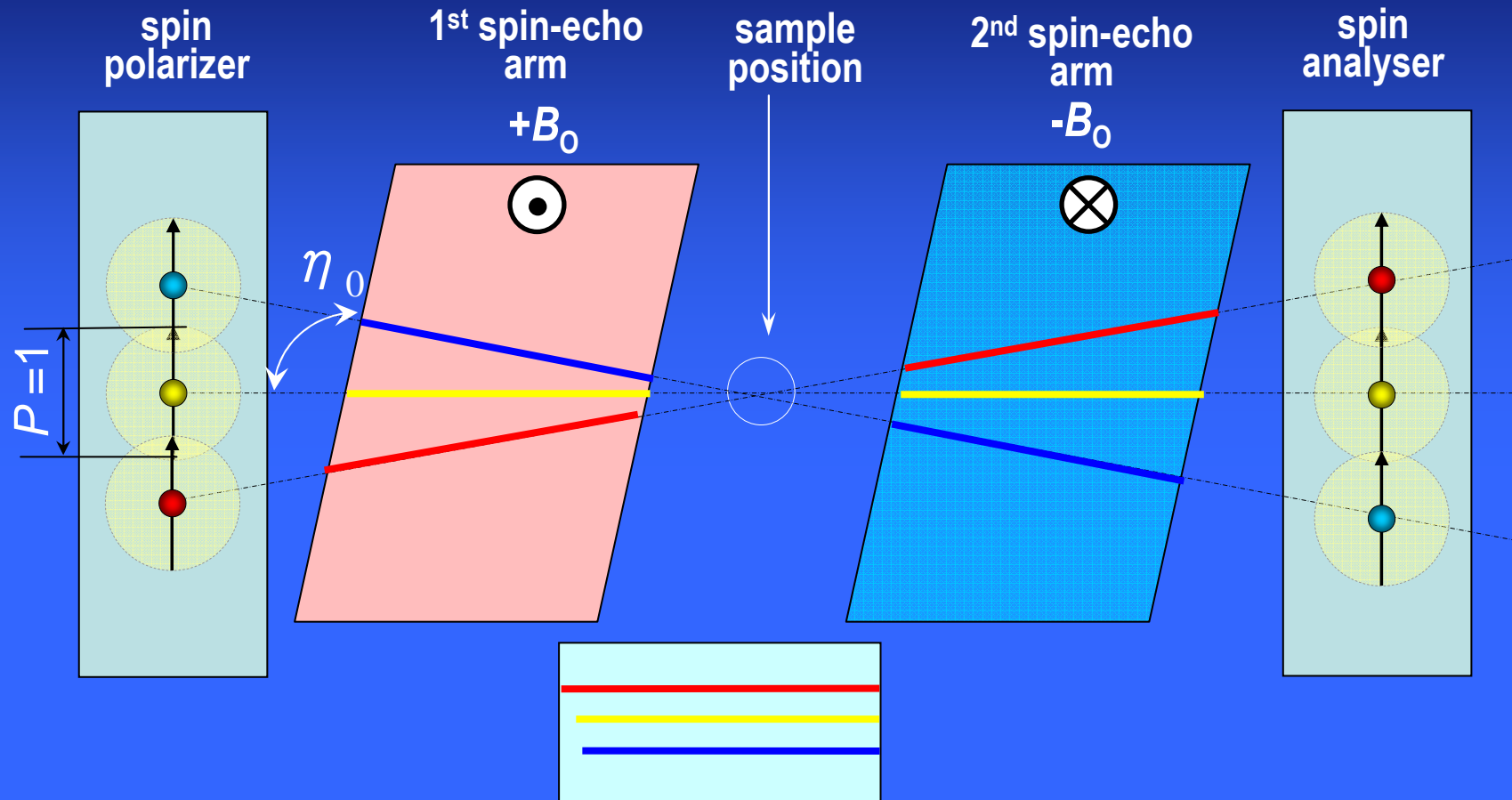
$P = \langle \cos \xi \rangle = \frac{\int \cos \left(\frac{\gamma B L \hbar}{m v^3} \omega \right) S(q, \omega) d\omega}{\int S(q, \omega) d\omega} = S(q, t_{SE})$

$t_{SE} = \frac{\gamma B L \hbar}{m v^3} \propto \lambda^3$

SPIN-ECHO (FOURIER) TIME

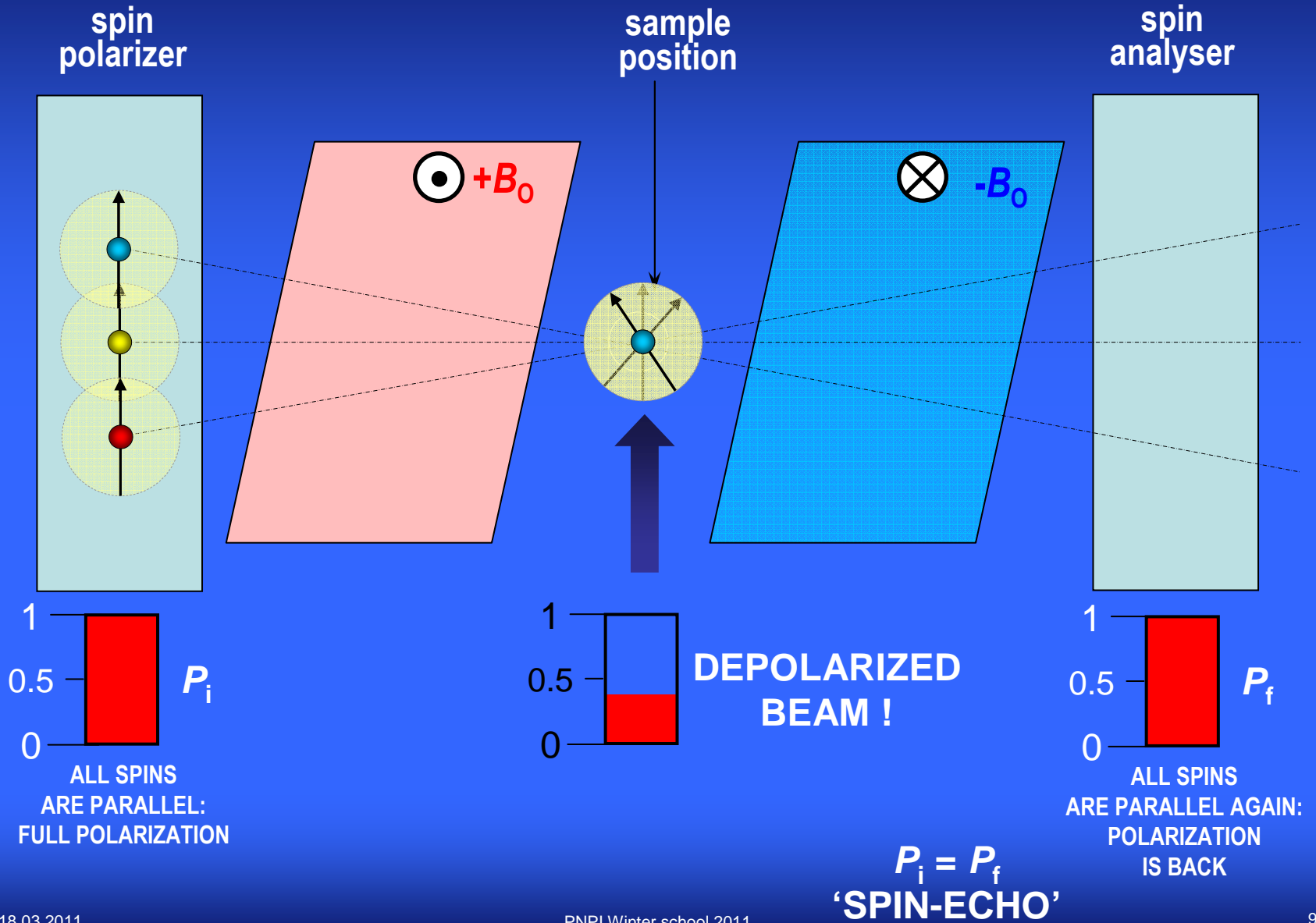
F. Mezei
 Z. Phys. **255** (1972) 146.

INCLINED BORDERS

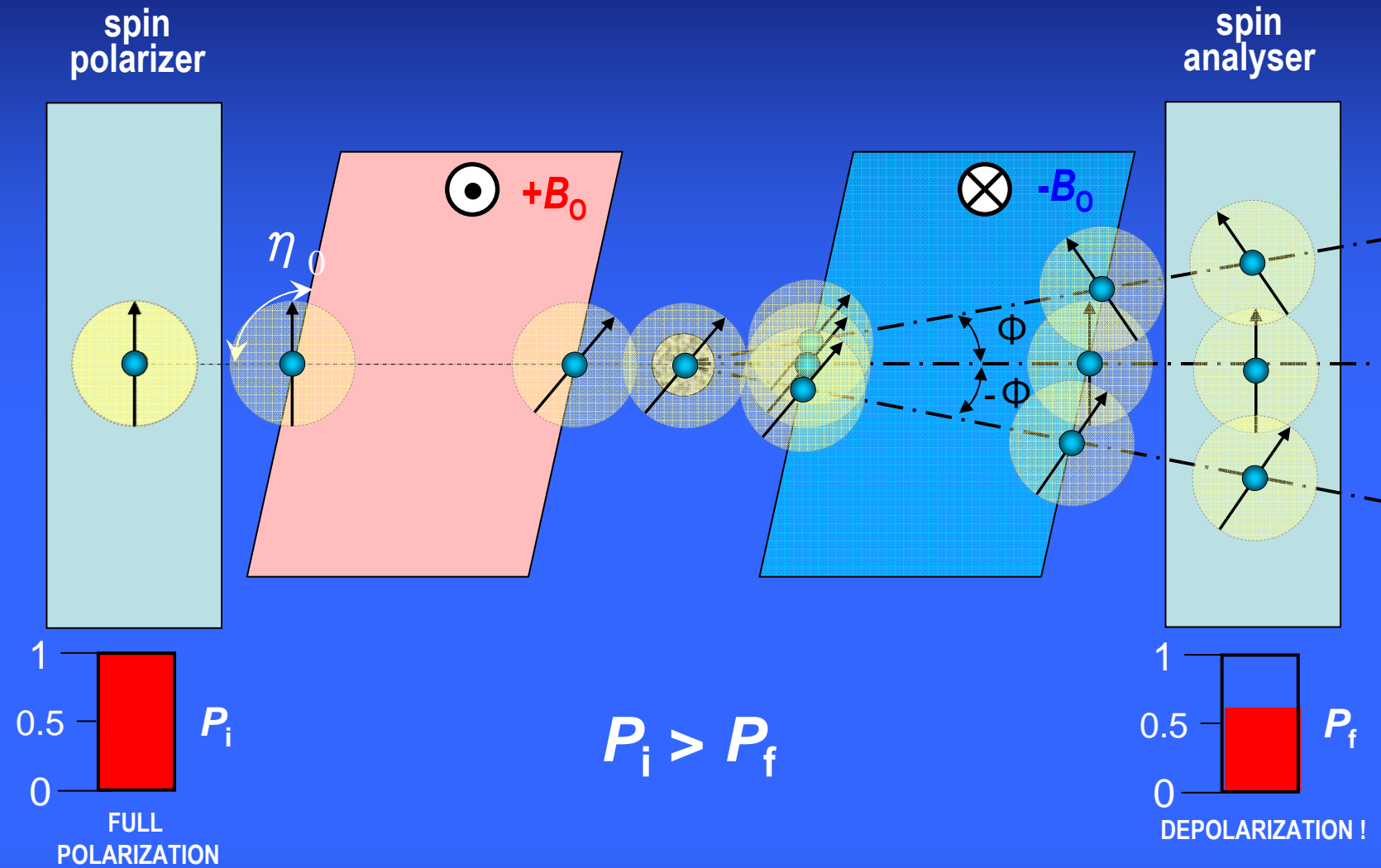


DIFFERENT PATH LENGTHS FOR THE DIFFERENT TRAJECTORIES !

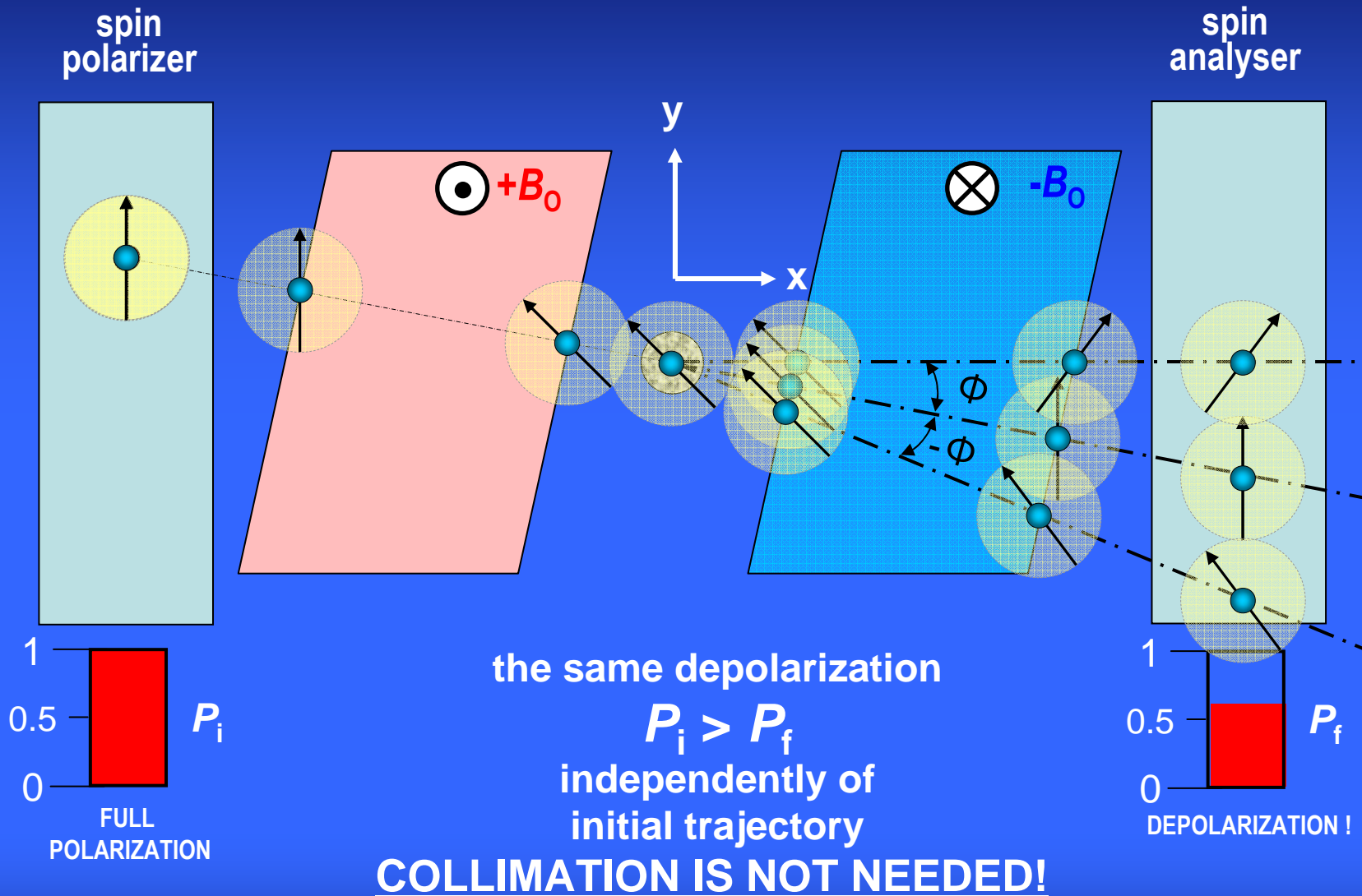
NO-SCATTERING CASE



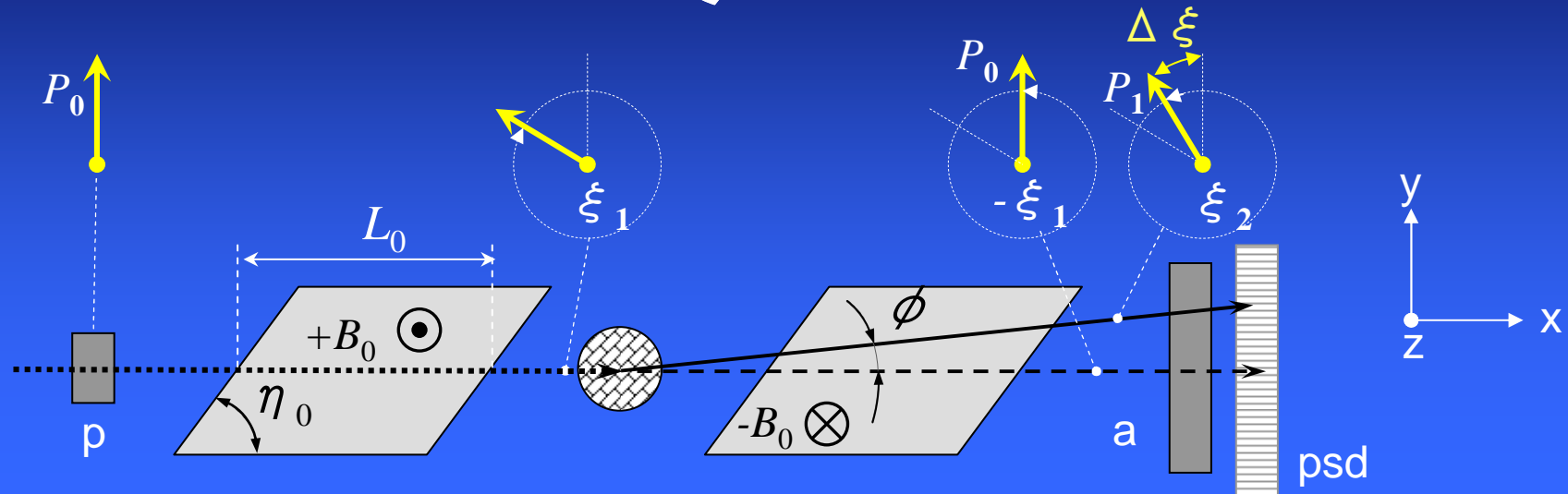
SCATTERING BY THE SAMPLE



SCATTERING BY THE SAMPLE



SPIN-ECHO ANGULAR ENCODING: THE EQUATIONS



$$\Delta \xi = \xi_1 - \xi_2 = 2\pi\gamma_n B_0 \frac{L_0}{v} \left(1 - \frac{1}{\cos \phi + \sin \phi \cot \eta_0} \right) \cong \left(2\pi\gamma_n \frac{B_0 L_0}{v} \cot \eta_0 \right) \sin \phi =$$

$$= \left(\frac{\gamma_n B_0 L_0 \lambda^2}{K} \cot \eta_0 \right) \left(\frac{2\pi}{\lambda} \sin \phi \right) \equiv \delta_y^{\text{SE}} q_y$$

$$P_1 = P_0 \cos \Delta \xi.$$

In our experiments:
SE length \$\delta\$ is tuned mechanically by changing \$\eta_0\$

SPIN-ECHO GIVES RESULTS IN REAL SPACE

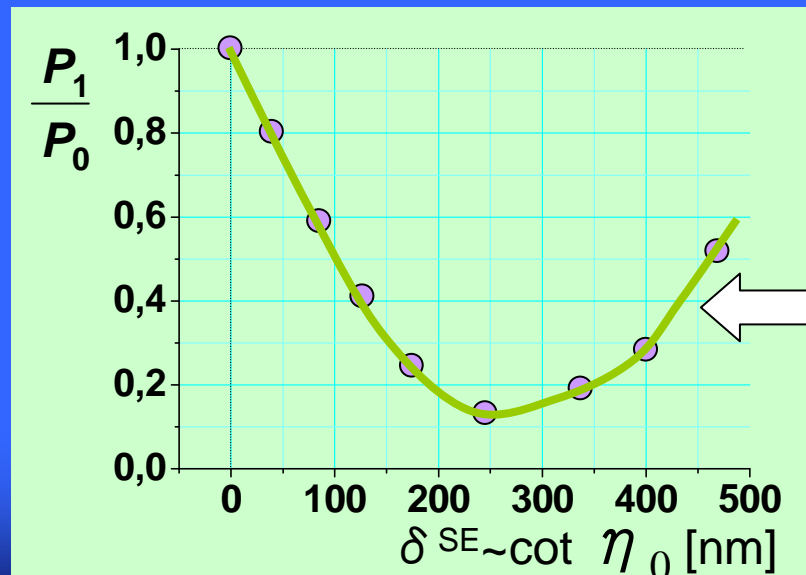
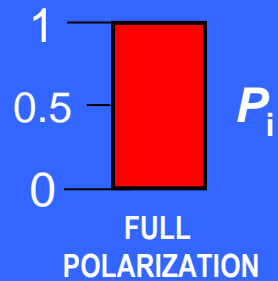
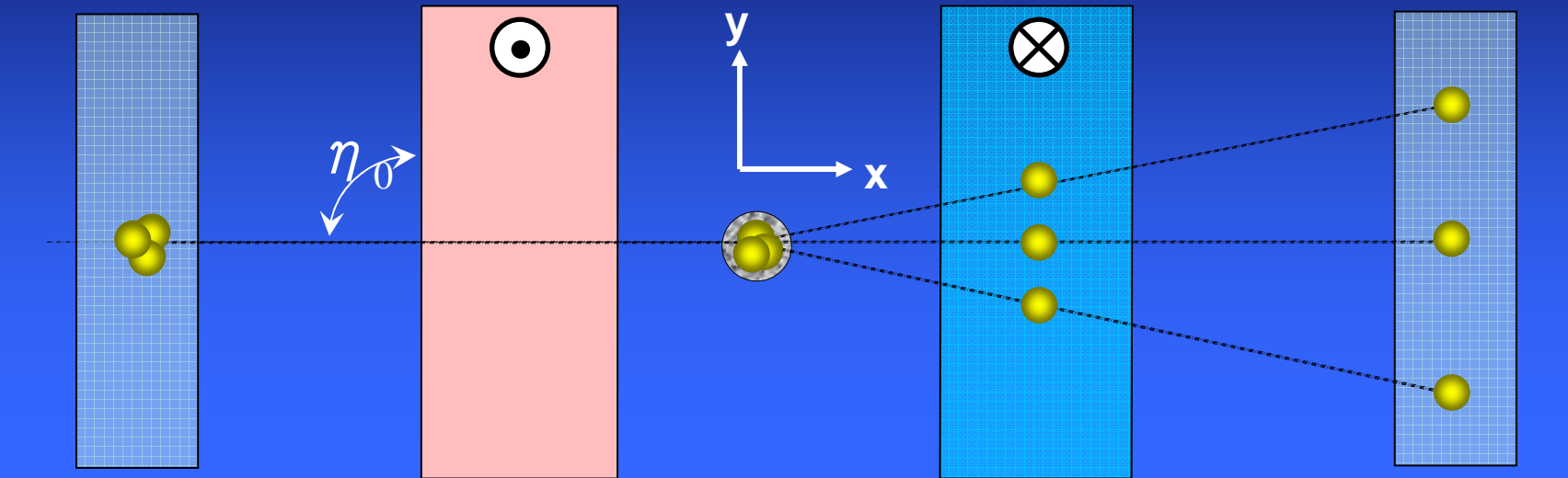
$$P_1 = P_0 \cos \Delta\xi.$$

$$\frac{P_1}{P_0} = \langle \cos \Delta\xi \rangle \propto \frac{\int_{\det} dq_y dq_z S(\mathbf{q}) \cos(\delta_y^{\text{SE}} q_y)}{\int_{\det} dq_y dq_z S(\mathbf{q})} = \int dx \Pi(x, y, 0) \equiv G(y),$$

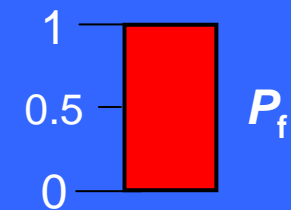
$$q_z = 0$$

$$\Pi(\mathbf{R}) = \int d\mathbf{r} \rho(\mathbf{r}) \rho(\mathbf{r} + \mathbf{R})$$

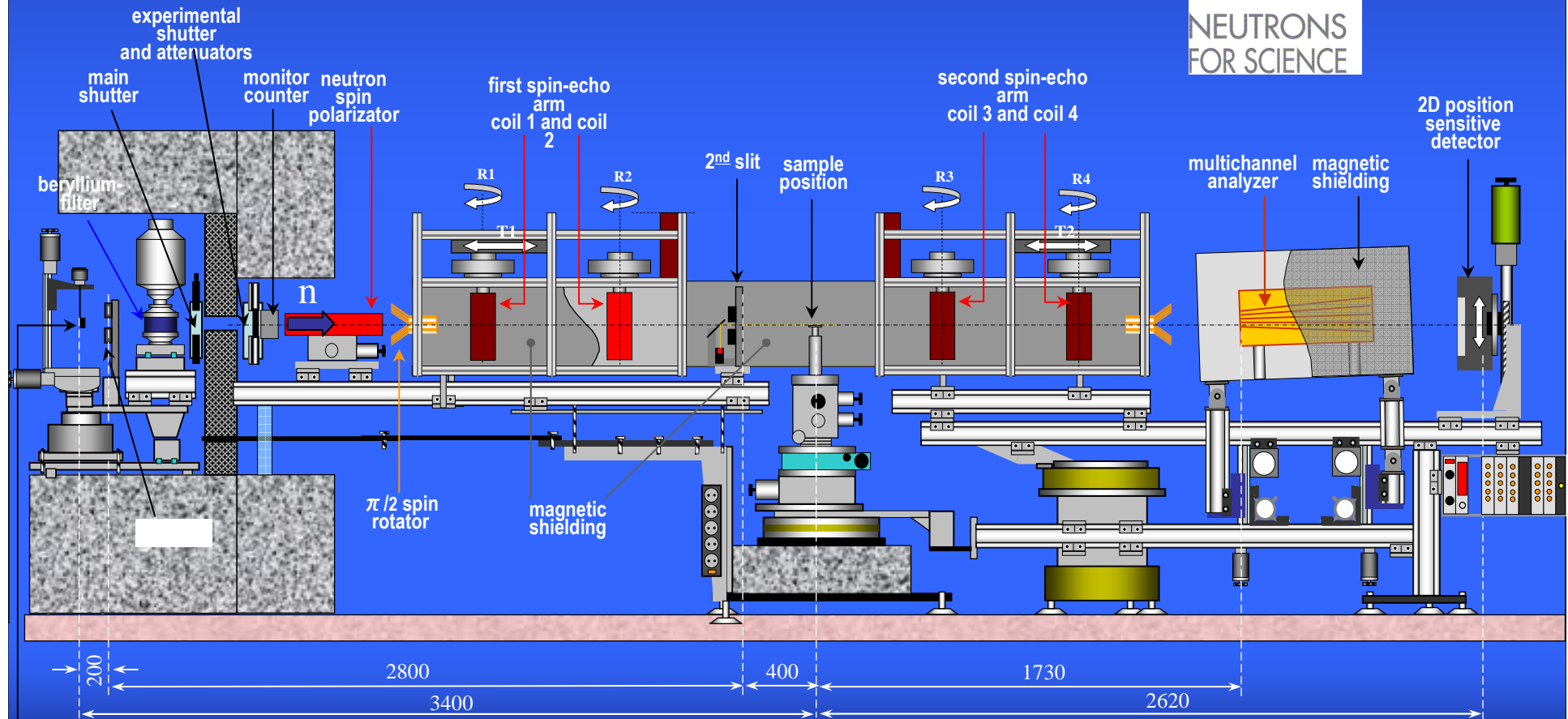
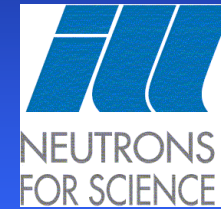
THE EXPERIMENT



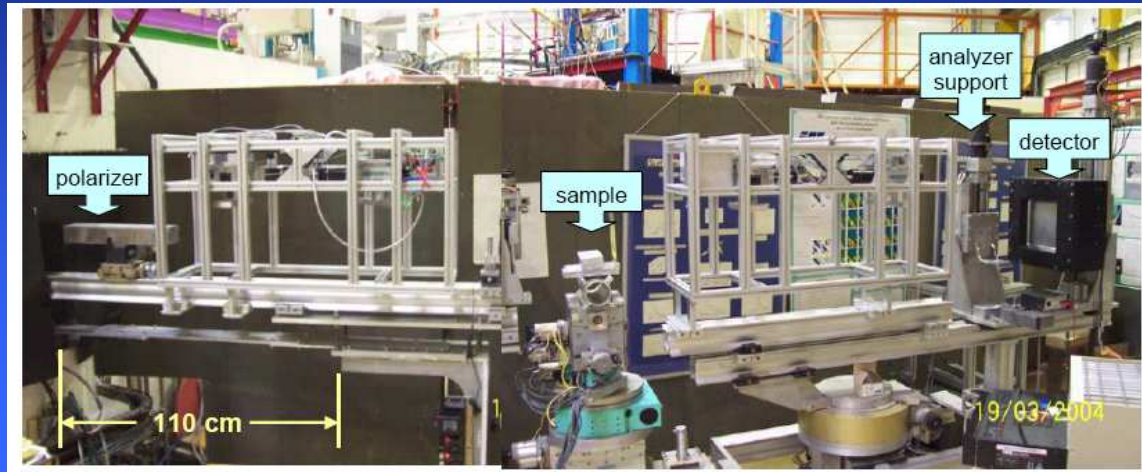
**REAL-SPACE
CORRELATION
FUNCTION**



EVA REFLECTOMETER TRANSFORMED INTO A SERGIS PROTOTYPE INSTRUMENT



EVA DURING THE TRANSFORMATION TO SERGIS



Beam size 50x5mm

Wave numbers covered:

$$1 \cdot 10^{-3} - 4 \cdot 10^{-2} \text{ \AA}^{-1}$$

Max. SE time in classical configuration ($\eta_0=0$) 0.07ns

Max. spin echo length 4500 Å

$$\delta = \left\{ \frac{\gamma_n B d \lambda \cdot \cot \Theta}{v} \right\}$$

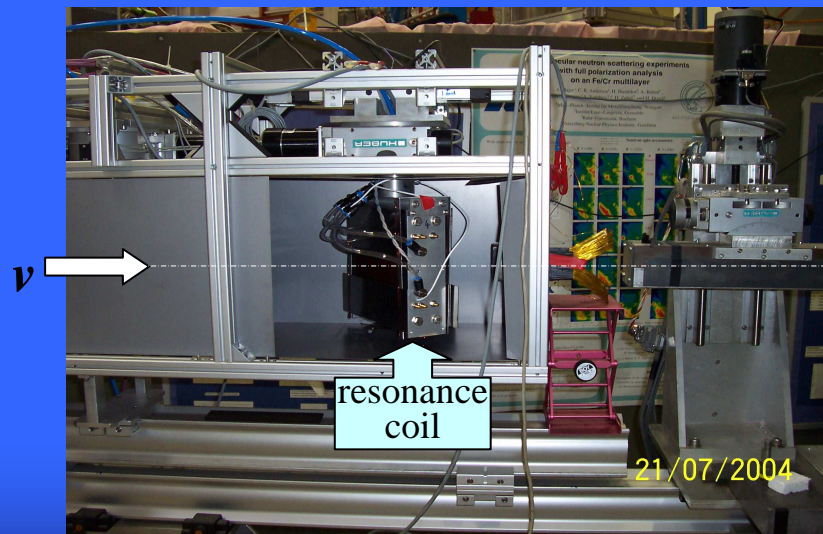
λ (neutron wavelength) 5.5 Å

v (neutron velocity) 720 m/s

Θ (tilt of precession coil) 50°

B (magnetic field in leg) 310G

d (length of precession leg) 50 cm

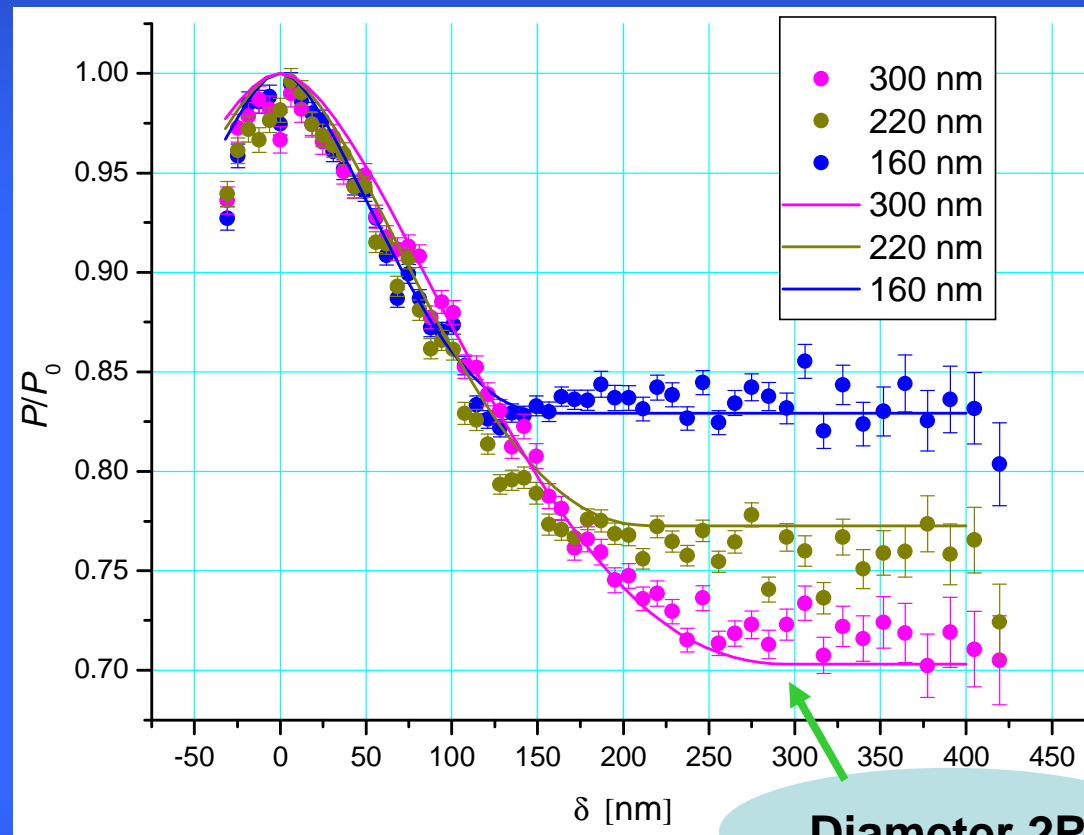


EVA reflectometer transformed into a SERGIS prototype instrument



Test SESANS experiments: polystyrene spheres

2.5% polystyrene balls in 3:1 D₂O/H₂O
2mm thick cell



SESANS: first experiments, case of concentrated colloids

J. Appl. Cryst. (2003). **36**, 1417–1423

Structural transitions of hard-sphere colloids studied by spin-echo small-angle neutron scattering

Timofei Krouglov,^{a*} Wim G. Bouwman,^a Jeroen Plomp,^a M. Theo Rekveldt,^a
Gert Jan Vroege,^b Andrei V. Petukhov^b and Dominique M. E. Thies-Weesie^b

^aInterfaculty Reactor Institute, Delft University of Technology, Mekelweg 15, 2629 JB Delft, The Netherlands, and ^bvan't Hoff Laboratory for Physical and Colloid Chemistry, Debye Institute, University of Utrecht, Padualaan 8, 3508 TB, Utrecht, The Netherlands. Correspondence e-mail: krouglov@iri.tudelft.nl

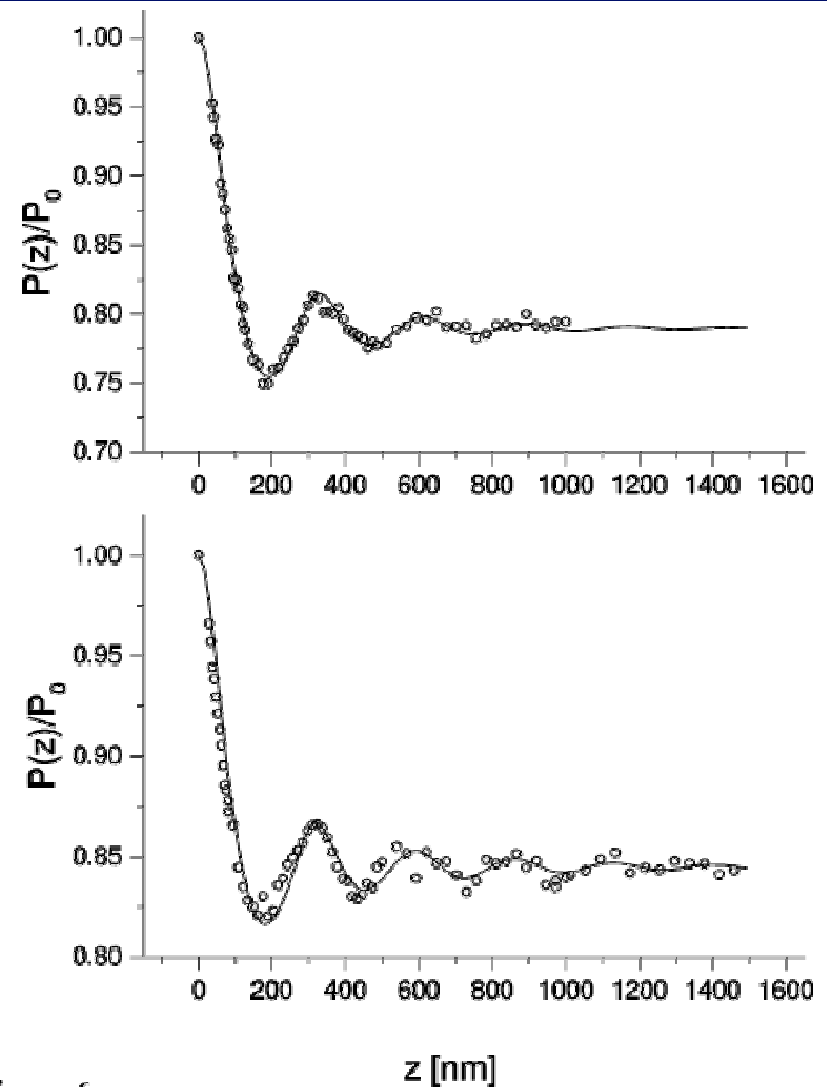
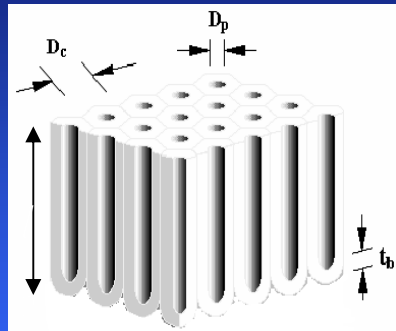


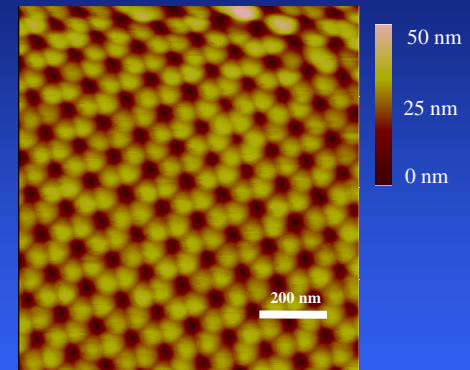
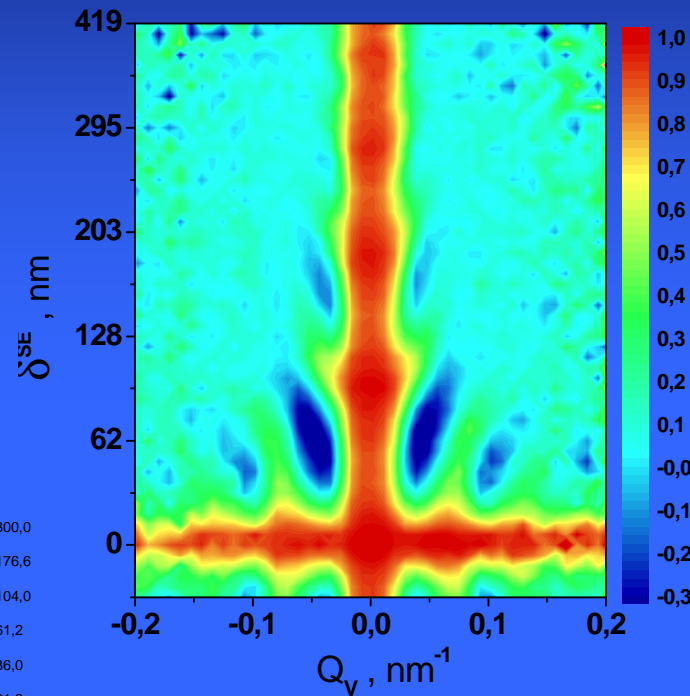
Figure 6
The solution from Fig. 5 after two weeks at rest. The top graph corresponds to the top of the sediment. The lower graph corresponds to the bottom of the sediment. Lines: Percus–Yevick solution for a hard-sphere liquid with $\varphi_V = 0.4$ (top) and $\varphi_V = 0.5$ (bottom). $R = 149$ nm.

SESANS EXAMPLE: Anodized Aluminum Oxide



AAO scheme

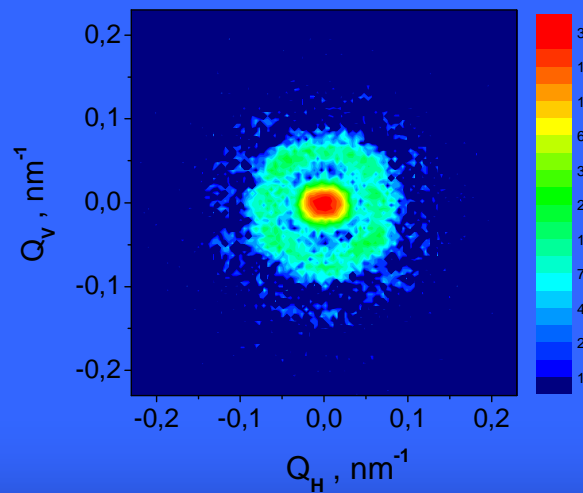
RECIPROCAL & REAL SPACE DATA (SESANS)



REAL SPACE (AFM)

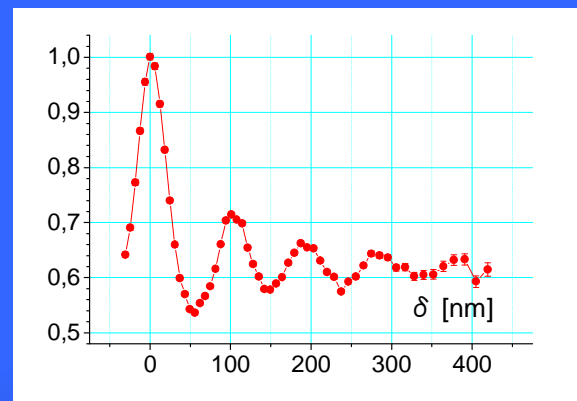
D_C , pore-to-pore distance = 120nm
 D_P , pore diameter = 50-60 nm

RECIPROCAL SPACE (SANS)



SANS:
 $D_C = 2\pi / \Delta Q = 100 \text{ nm}$

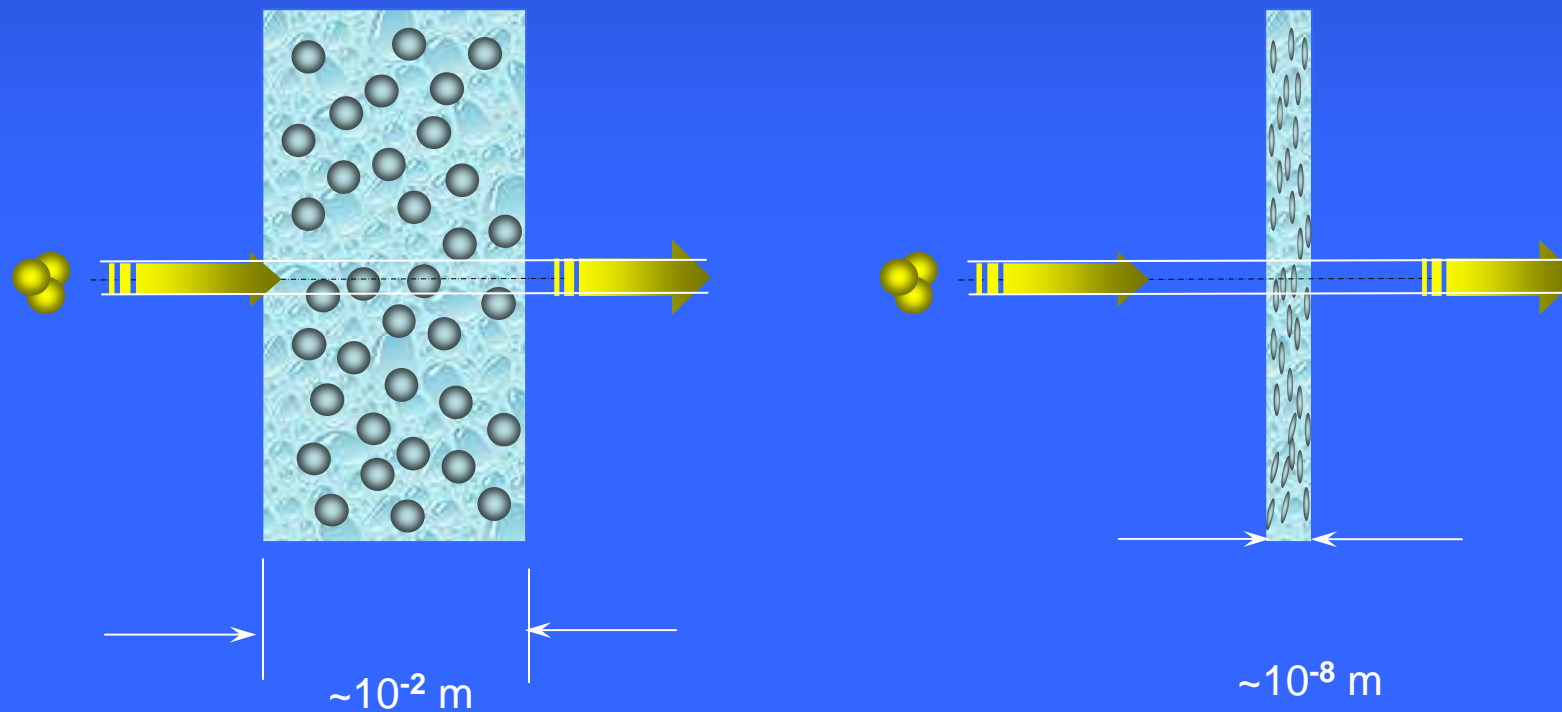
RECIPROCAL² SPACE (SESANS) = REAL SPACE CORRELATION FUNCTION



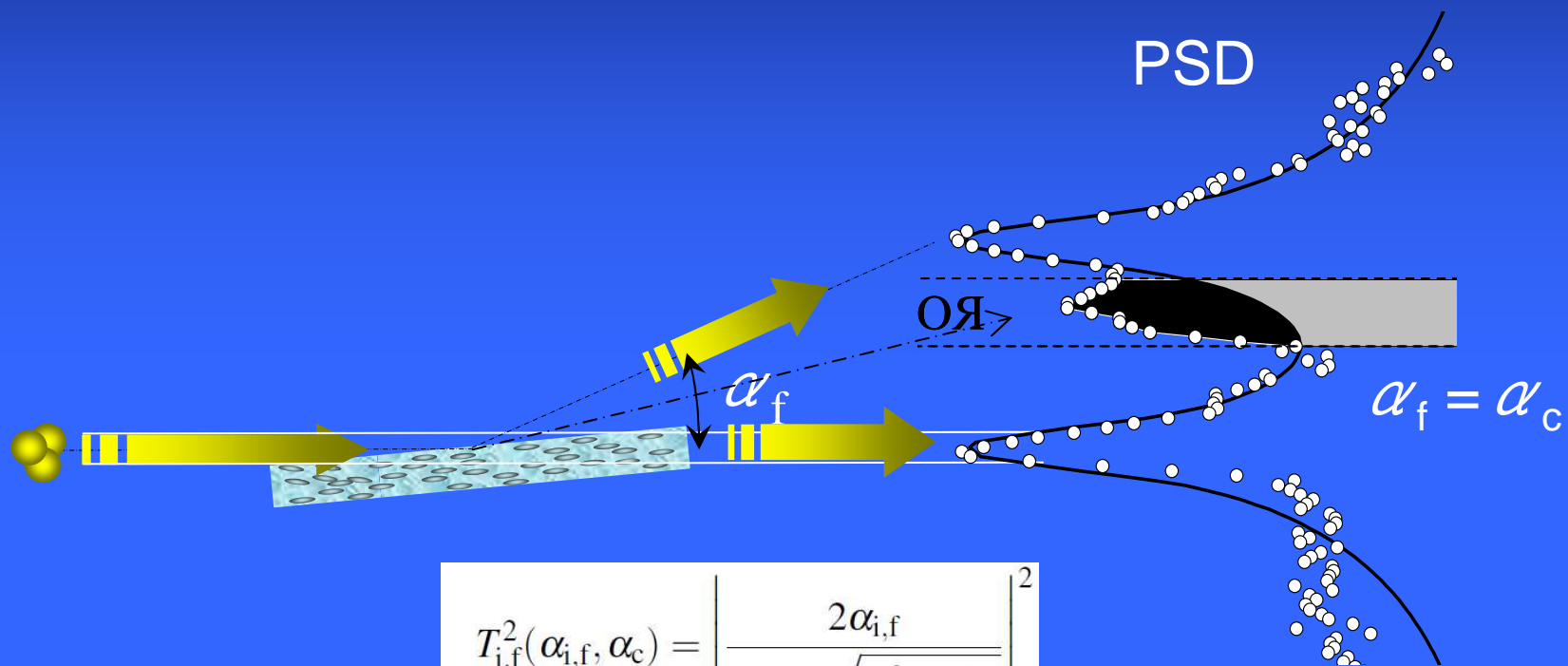
SESANS:
 $D_C = 100 \text{ nm}$

GRAZING INCIDENCE

TRANSMISSION:
what to do with a very thin sample?



GRAZING INCIDENCE



$$T_{i,f}^2(\alpha_{i,f}, \alpha_c) = \left| \frac{2\alpha_{i,f}}{\alpha_{i,f} + \sqrt{\alpha_{i,f}^2 - \alpha_c^2}} \right|^2$$

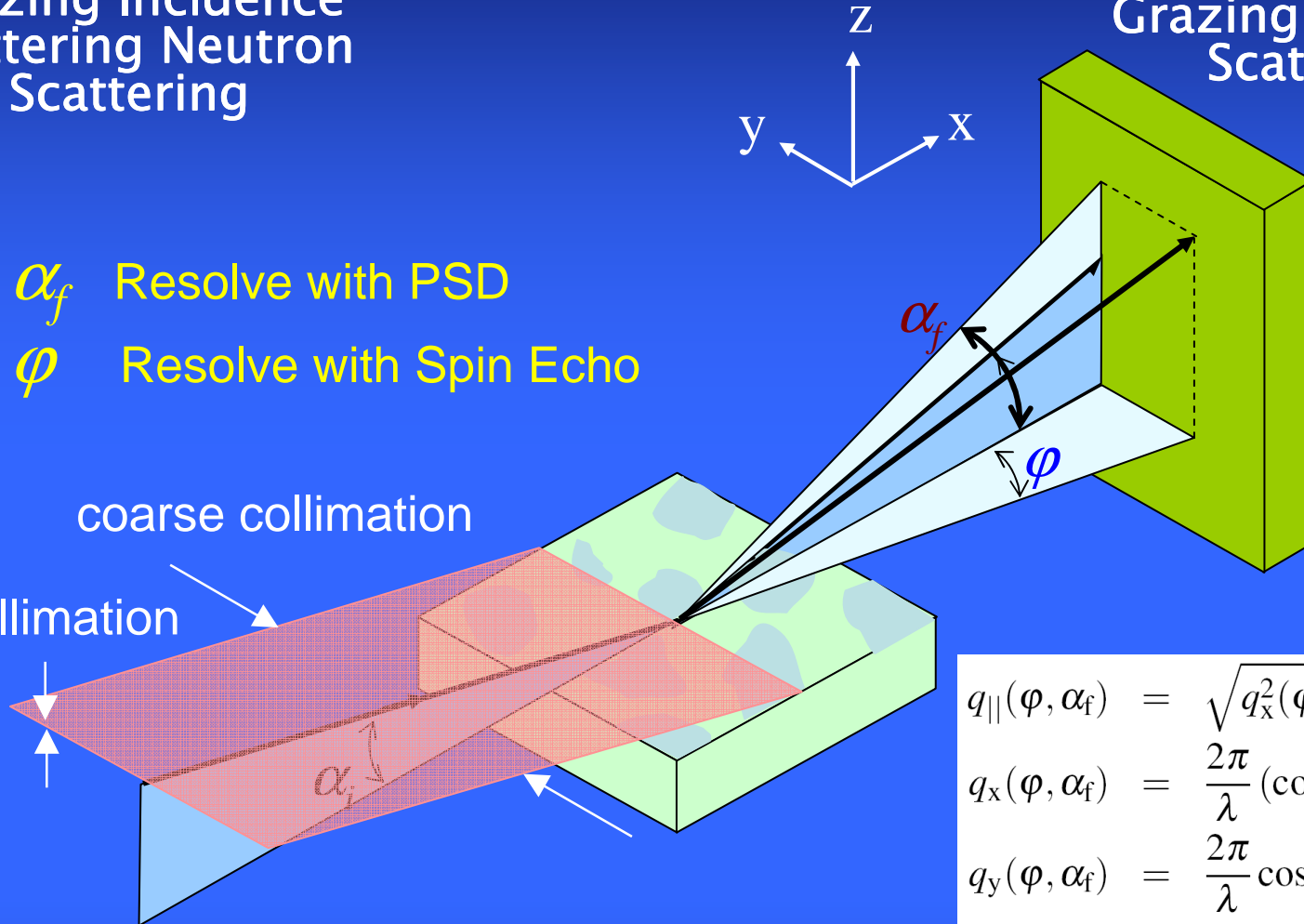
GISANS vs. SERGIS

Grazing Incidence
Scattering Neutron
Scattering

Spin-Echo Resolved
Grazing Incidence
Scattering

α_f Resolve with PSD
 ϕ Resolve with Spin Echo

coarse collimation
tight collimation



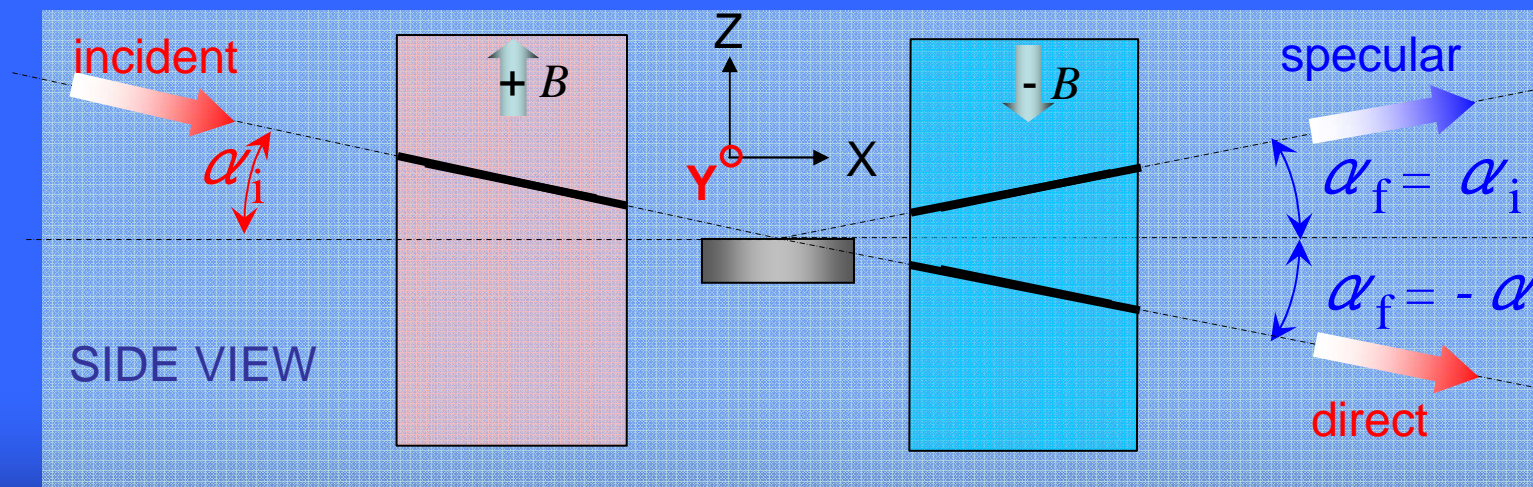
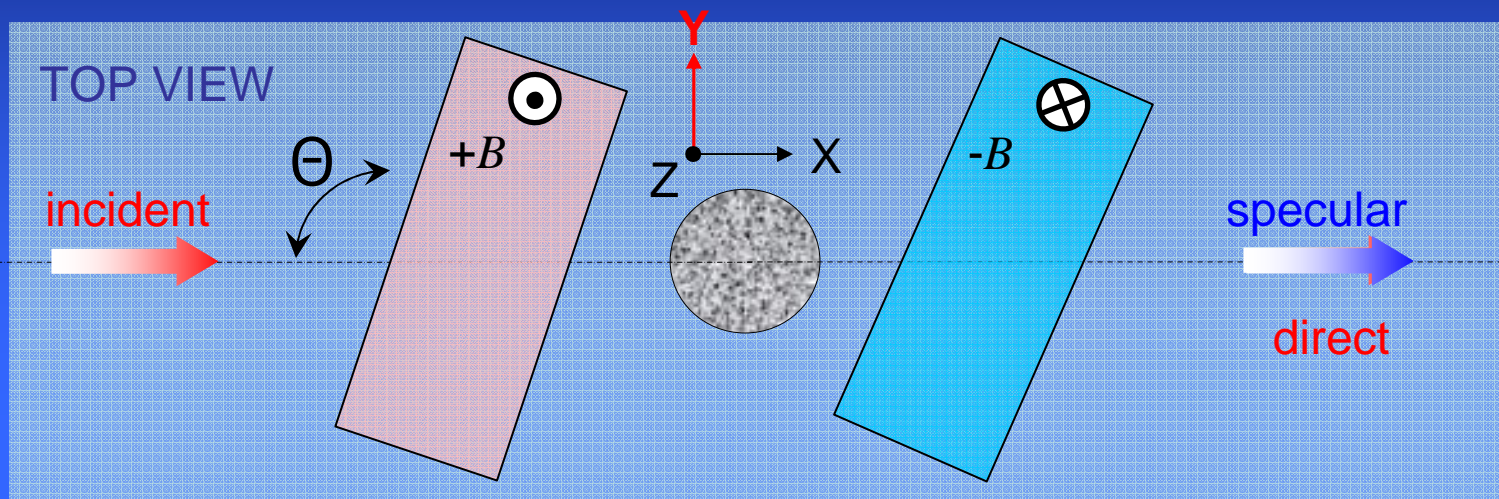
$$q_{||}(\phi, \alpha_f) = \sqrt{q_x^2(\phi, \alpha_f) + q_y^2(\phi, \alpha_f)}$$

$$q_x(\phi, \alpha_f) = \frac{2\pi}{\lambda} (\cos \alpha_f \cos \phi - \cos \alpha_i)$$

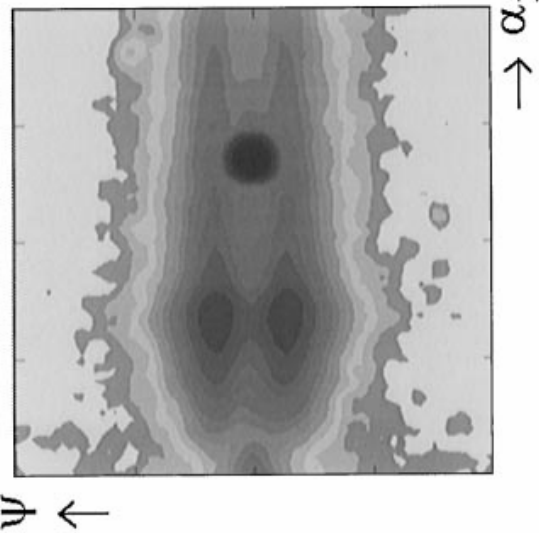
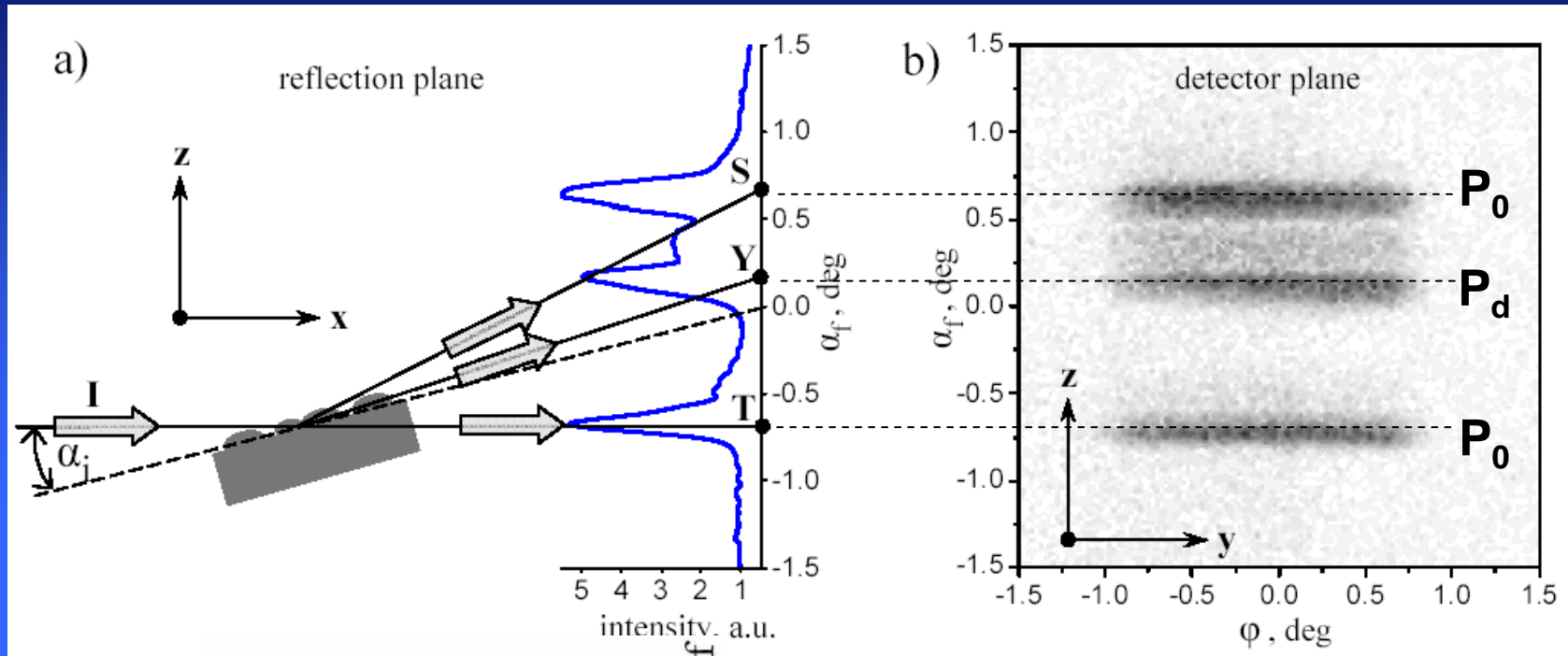
$$q_y(\phi, \alpha_f) = \frac{2\pi}{\lambda} \cos \alpha_f \sin \phi$$

$$q_z(\phi, \alpha_f) = \frac{2\pi}{\lambda} (\sin \alpha_f + \sin \alpha_i)$$

THE SAME POLARIZATION IN DIRECT AND SPECULAR BEAMS



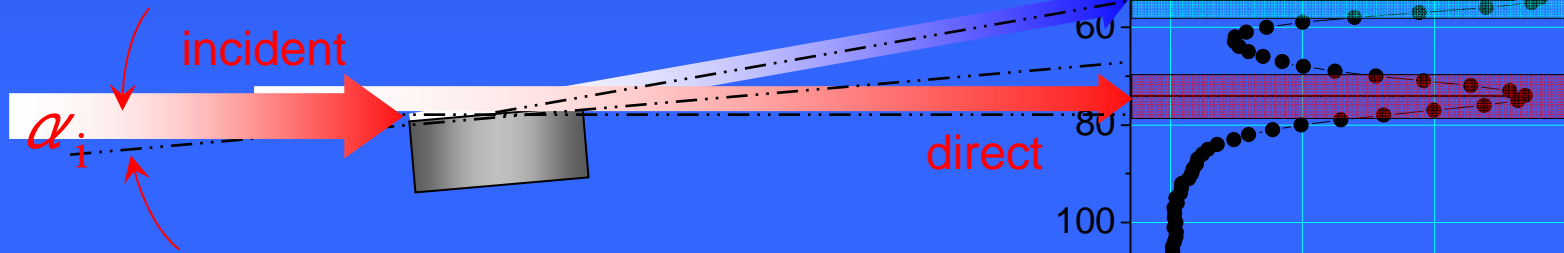
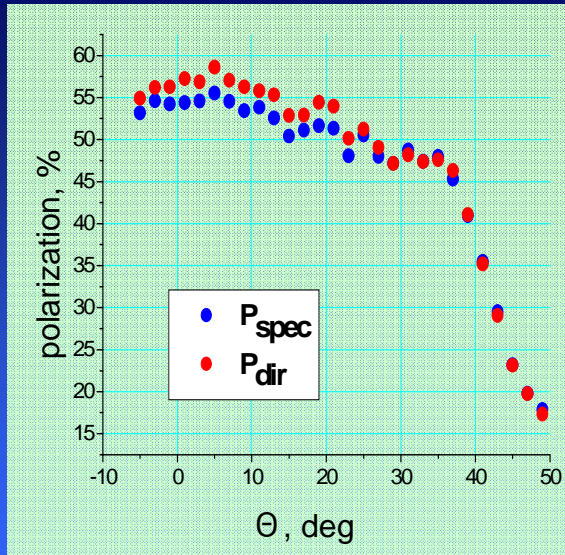
SERGIS



a) The scattering geometry. The incident beam (I) impinges on the sample surface at a shallow angle α_i ; transmitted (T), specular (S) and diffuse (Y) intensities are simultaneously recorded by PSD. b) Image taken by 2-dimensional PSD during real experiment. The size of the incoming beam at the sample position was $30 \times 2 \text{ mm}^2$.

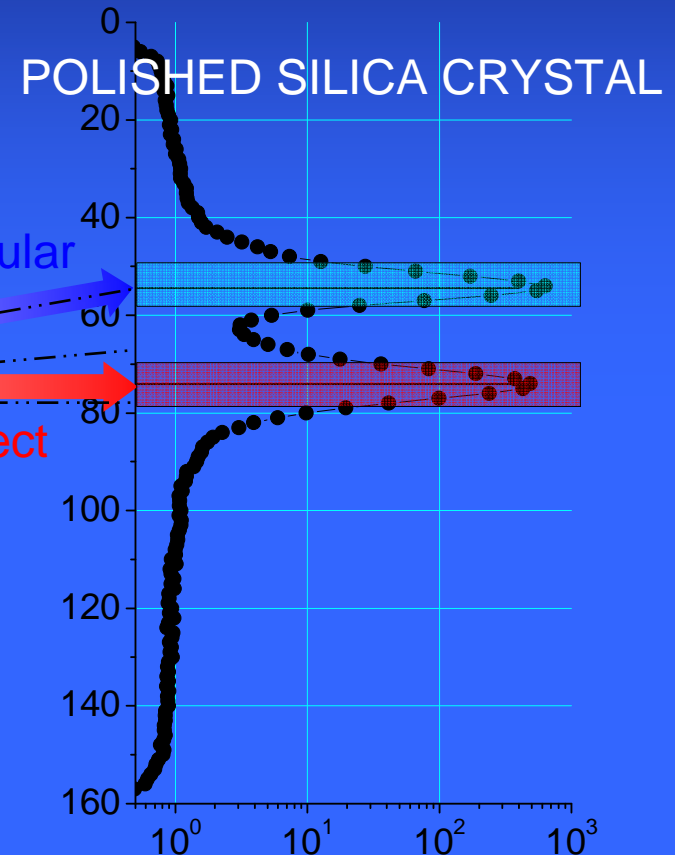
GISANS

REFLECTIVITY REFERENCE MEASUREMENT



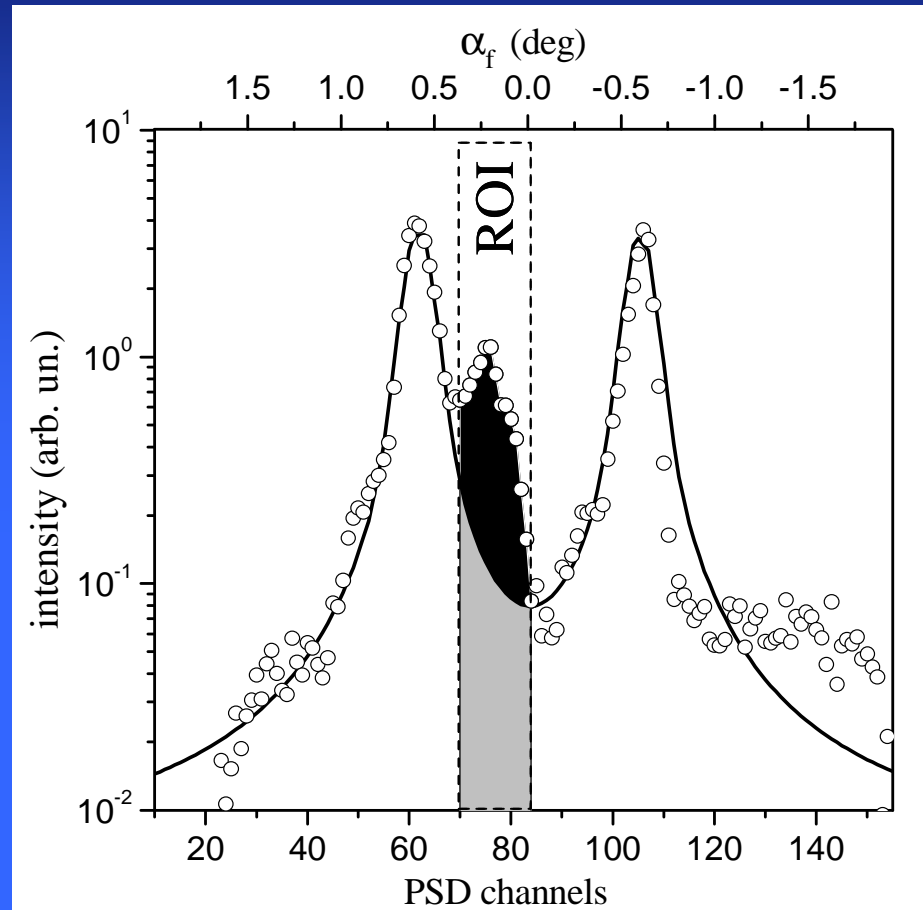
possible reference data in reflection mode:

- separate scan with no sample
- separate scan with a reference sample
- direct beam (at high α_i)
- specular beam (at high α_i)



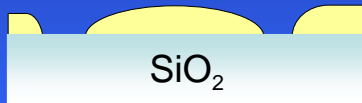
possible reference data in transmission mode:
• separate scan with no sample

“PURIFICATION” OF THE SIGNAL

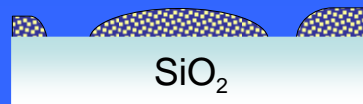


$$\frac{P_d}{P_0} = \frac{P_{ROI}}{P_0} - \frac{1}{C} \left(1 - \frac{P_{ROI}}{P_0} \right)$$

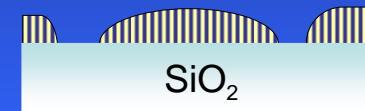
SAMPLES: DEWETED POLYMER FILMS



dPS
deuterated
polystyrene

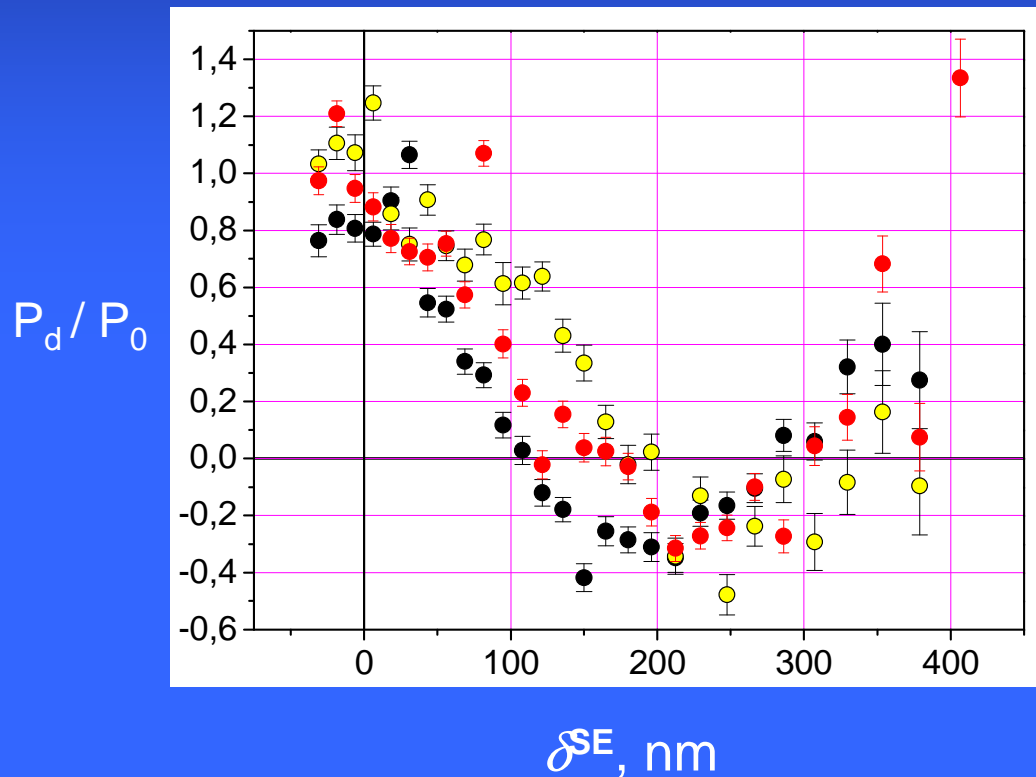


polymer
blend
PpMS:dPS = 3:2
polyparamethylstyrene
polystyrene



diblock
copolymer
poly(styren-block-
paramethylstyrene)
P(S-b-pMS)
regular phase
separation

SERGIS EXPERIMENTAL DATA



● HOMOPOLYMER
pancake-type
droplets

● BLEND
pancake-type
droplets

● DIBLOCK
'spherical'
droplets

DATA ANALYSIS IN SERGIS

Modeling of the scattering from the dewetted polymer droplets

$$\frac{P_1}{P_0} = \langle \cos \Delta \xi \rangle \propto \frac{\int_{\text{det}} dq_y dq_z S(\mathbf{q}) \cos(\delta_y^{\text{SE}} q_y)}{\int_{\text{det}} dq_y dq_z S(\mathbf{q})} = \int dx \Pi(x, y, 0) \equiv G(y),$$

Specific of grazing incidence scattering:
framing of the form-factor by the Fresnel
transmission coefficients

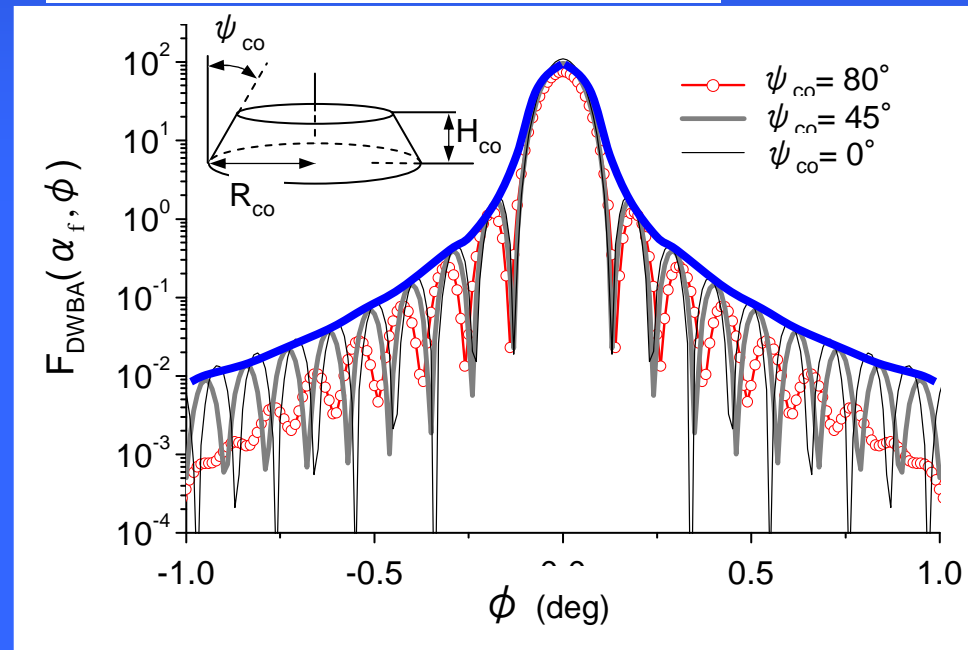
$$S(q) = |F_{\text{BA}}|^2 \cdot T_i^2(\alpha_i) \cdot T_f^2(\alpha_f) \cdot I_{\text{H}}(\varphi, \alpha_f)$$

CONE FORM FACTOR IN THE CASE OF PANCAKE-LIKE OBJECTS

$$F_{\text{co}}(\varphi, \alpha_f) = \int_0^{H_{\text{co}}} Z_{\text{r}}^2(z, \psi_{\text{co}}) \frac{J_1(q_{\parallel}(\varphi, \alpha_f) \cdot Z_{\text{r}}(z, \psi_{\text{co}}))}{q_{\parallel}(\varphi, \alpha_f) \cdot Z_{\text{r}}(z, \psi_{\text{co}})} \exp\left(\frac{i}{2} q_z(\varphi, \alpha_f) z\right) dz$$

$$Z_{\text{r}}(z, \psi_{\text{co}}) = R_{\text{co}} - z / \cot \psi_{\text{co}}$$

$R_{\text{co}} = 150 \text{ nm}$
 $H_{\text{co}} = 10 \text{ nm}$

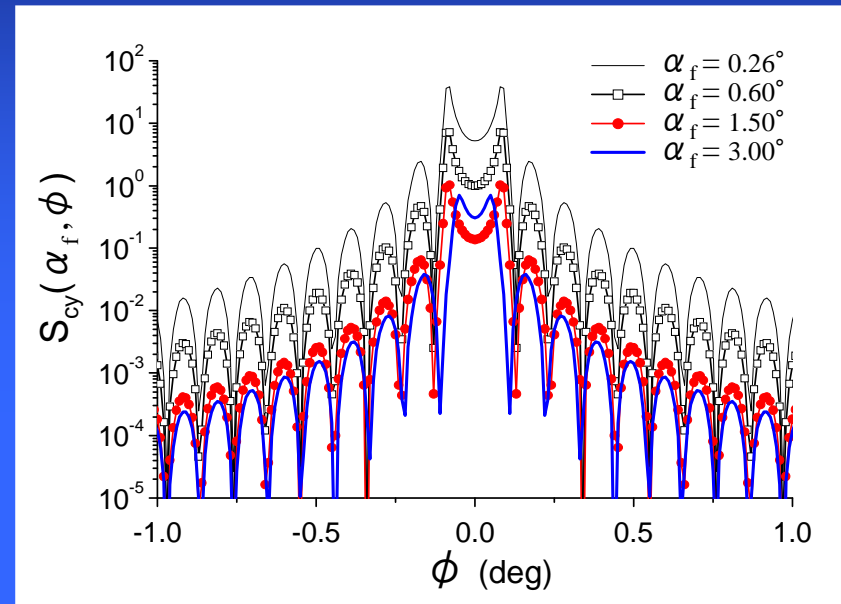
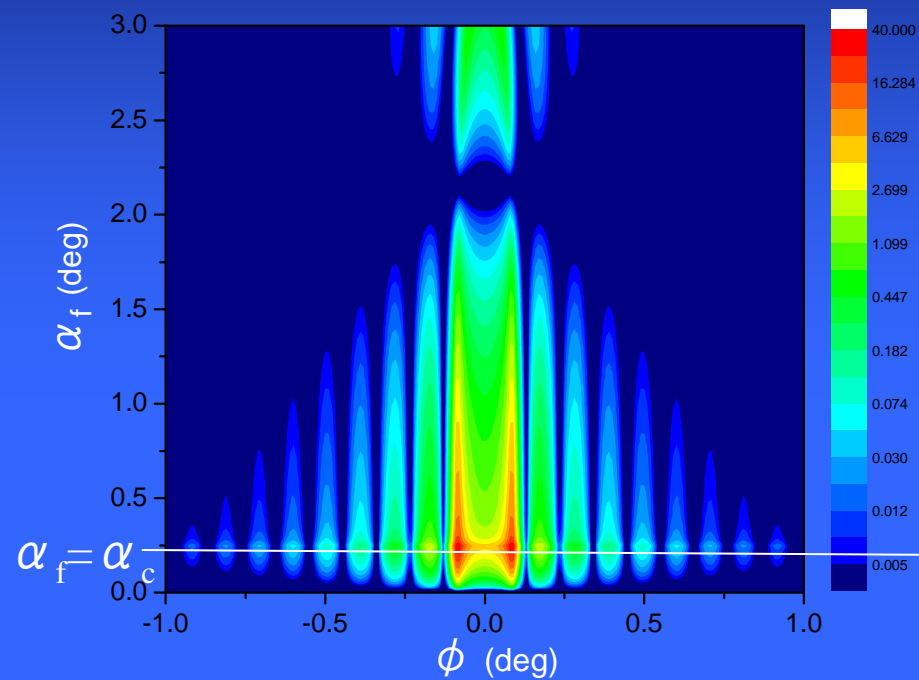


$\psi_{\text{co}} = 0^\circ$

cylinder

$$|F_{\text{cy}}(\varphi, \alpha_f)| = \frac{J_1(q_{\parallel}(\varphi, \alpha_f) R) \sin(q_z(\varphi, \alpha_f) H / 2)}{q_{\parallel}(\varphi, \alpha_f) R \quad q_z(\varphi, \alpha_f) H / 2}$$

CYLINDER FORM FACTOR AS SEEN IN THE 2d DETECTOR



α_i fixed

$\alpha_f = \alpha_c$ fixed

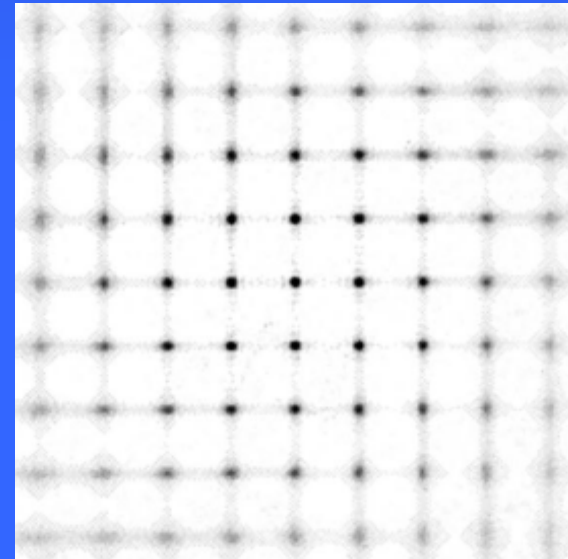
DATA ANALYSIS IN SERGIS

Choice of the interference function – structure factor of one-dimensional ideal paracrystal (Hosemann and Bagchi)

$$I_H(\varphi, \alpha_f) = \frac{1 - e^{-q_{\parallel}(\varphi, \alpha_f)\sigma^2}}{1 + e^{-q_{\parallel}(\varphi, \alpha_f)\sigma^2} - 2e^{-\frac{1}{2}q_{\parallel}(\varphi, \alpha_f)\sigma^2} \cos(Dq_{\parallel}(\varphi, \alpha_f))}$$

D – the mean value of the lattice parameter

σ – its standard deviation if the disorder factor obeys Gaussian distribution



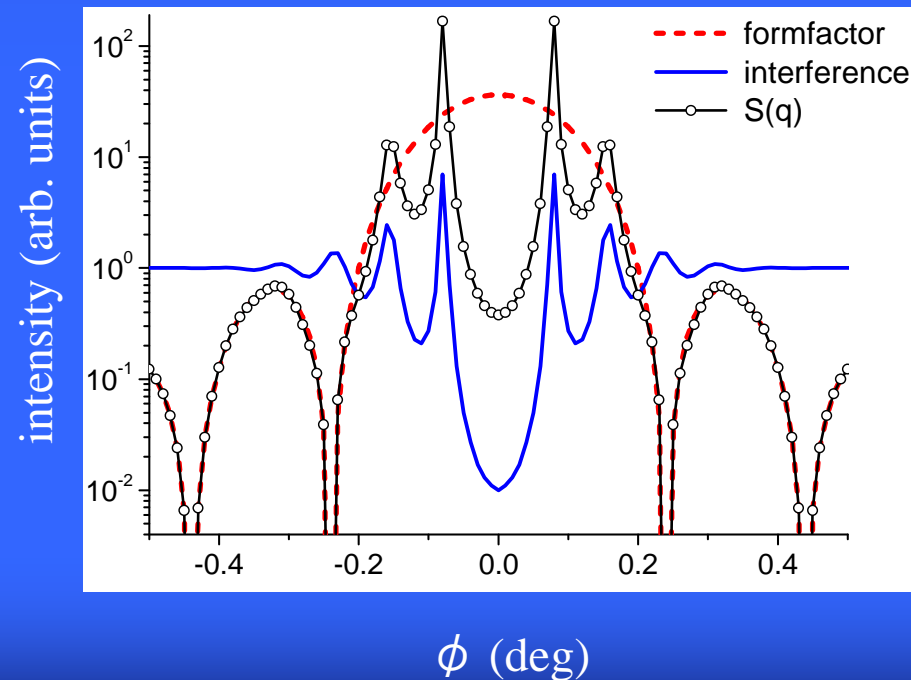
Hosemann, R.; Bagchi, S. N. *Direct Analysis of Diffraction by Matter* (North-Holland Publishing Company: Amsterdam, 1962).

SCATTERING INTENSITY DISTRIBUTION

$$S_{cy}(\varphi, \alpha_f) = M_c |F_{cy}(\varphi, \alpha_f)|^2 \cdot I_H(\varphi, \alpha_f)$$

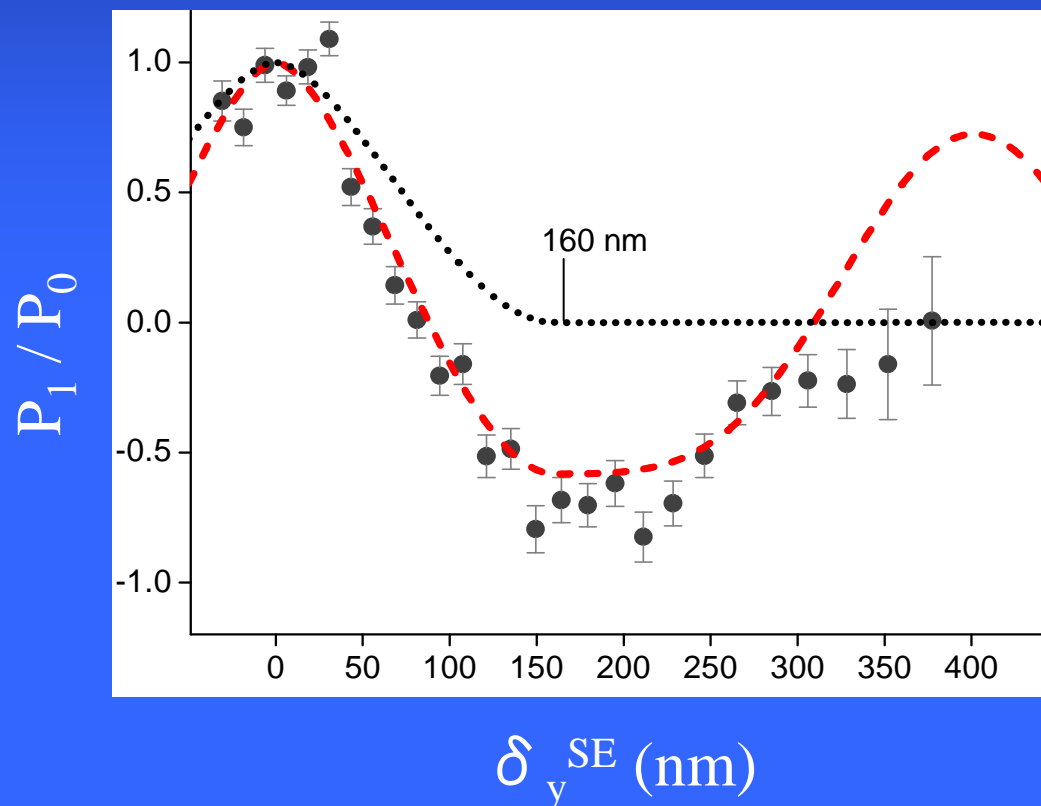
$$|F_{cy}(\varphi, \alpha_f)| = \frac{J_1(q_{||}(\varphi, \alpha_f)R)}{q_{||}(\varphi, \alpha_f)R} \frac{\sin(q_z(\varphi, \alpha_f)H/2)}{q_z(\varphi, \alpha_f)H/2}$$

$$I_H(\varphi, \alpha_f) = \frac{1 - e^{-q_{||}(\varphi, \alpha_f)\sigma^2}}{1 + e^{-q_{||}(\varphi, \alpha_f)\sigma^2} - 2e^{-\frac{1}{2}q_{||}(\varphi, \alpha_f)\sigma^2} \cos(Dq_{||}(\varphi, \alpha_f))}$$



SERGIS signal

$$\frac{P_1}{P_0}(\delta_y^{SE}) = \frac{\int_{-\varphi_{lim}}^{\varphi_{lim}} S_{cy}(\varphi, \bar{\alpha}_f) \cos(\delta_y^{SE}, \varphi) d\varphi}{\int_{-\varphi_{lim}}^{\varphi_{lim}} S_{cy}(\varphi, \bar{\alpha}_f) d\varphi}$$



dPS sample

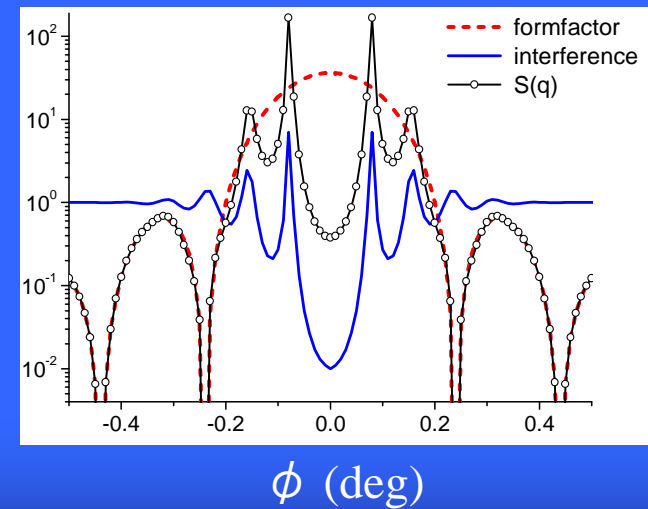
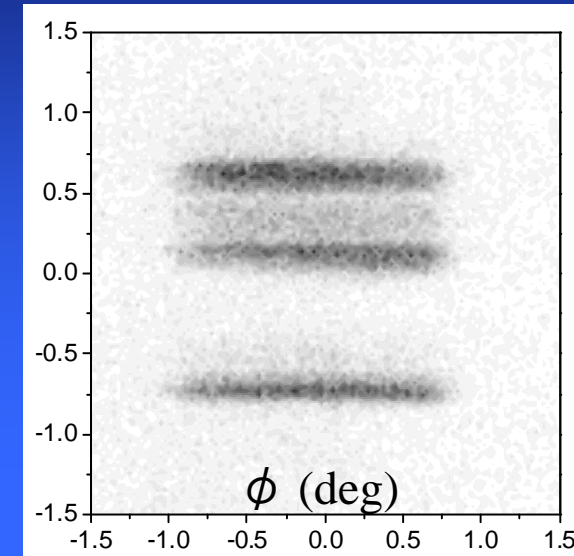
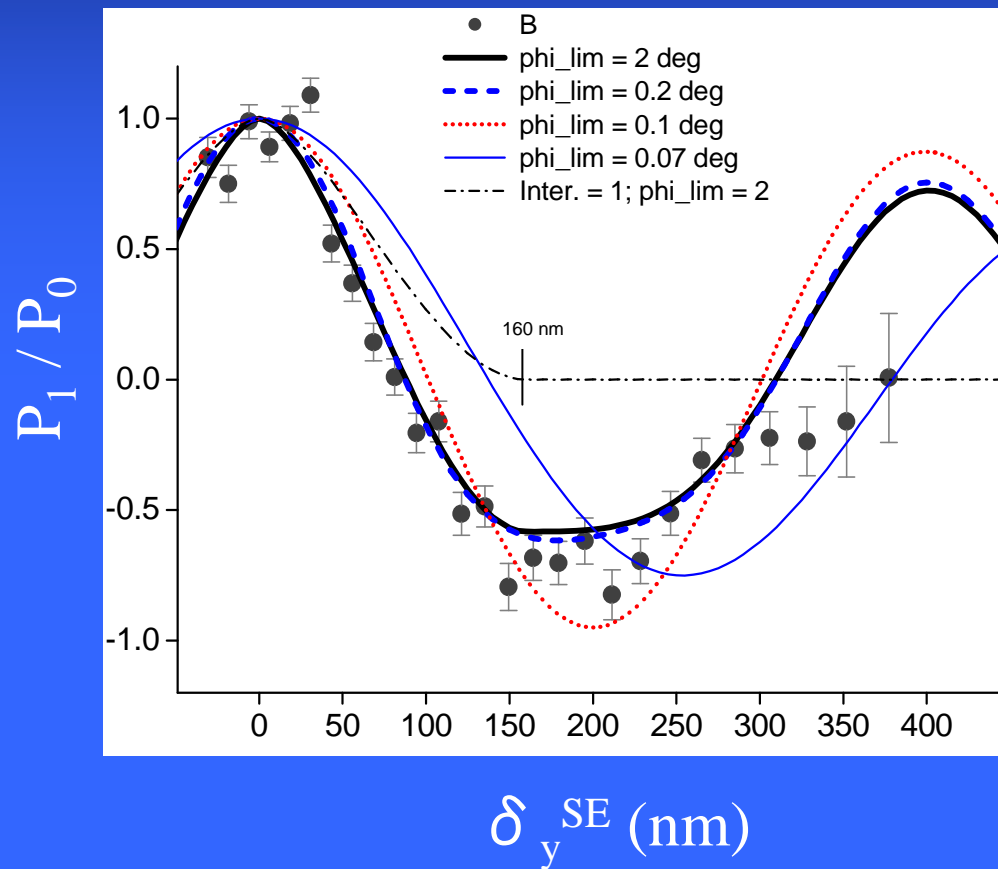
R=80 nm

H=10 nm

D=390 nm

$\sigma = 25$ nm

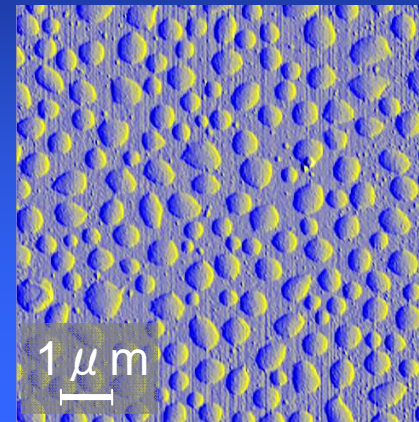
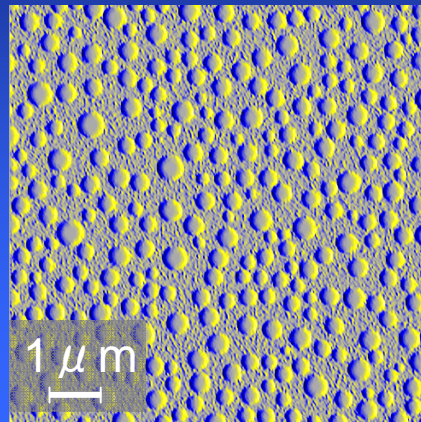
POSSIBLE EFFECT OF THE LIMITED SIZE OF THE DETECTOR ON THE SERGIS DATA



COMPLIMENTARY DATA – AFM

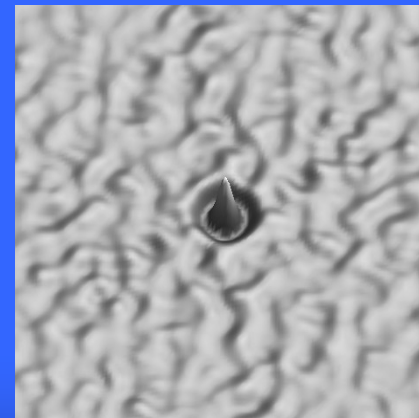
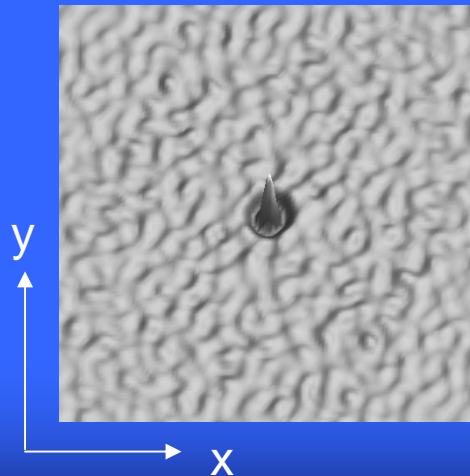
polymer blend

diblock copolymer

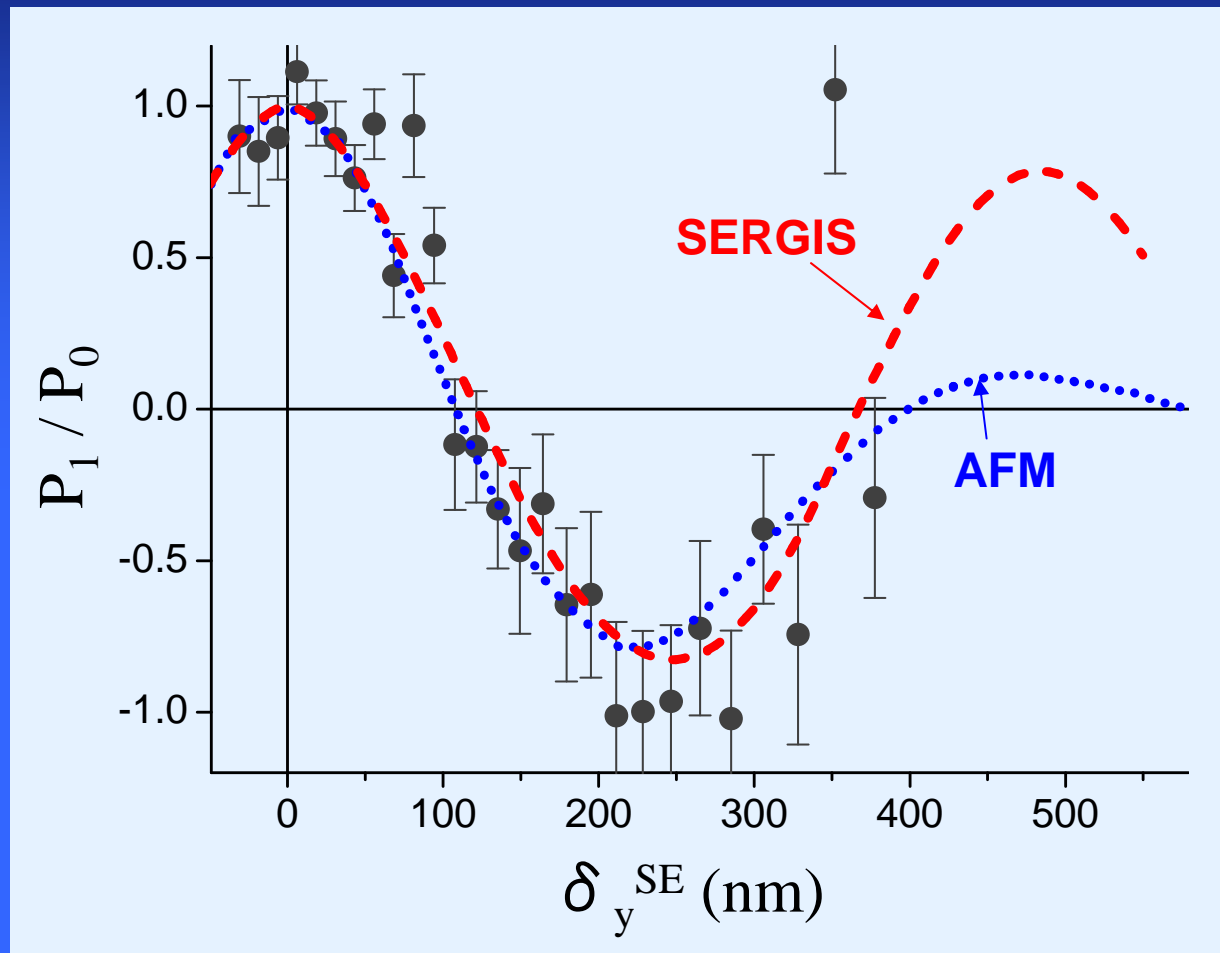


ACF

$$\Pi(\Delta a_1, \Delta a_2) = \sum \tilde{f}(a_1, a_2) \cdot \sum \tilde{f}(a_1 + \Delta a_1, a_2 + \Delta a_2)$$



POLYMER BLEND

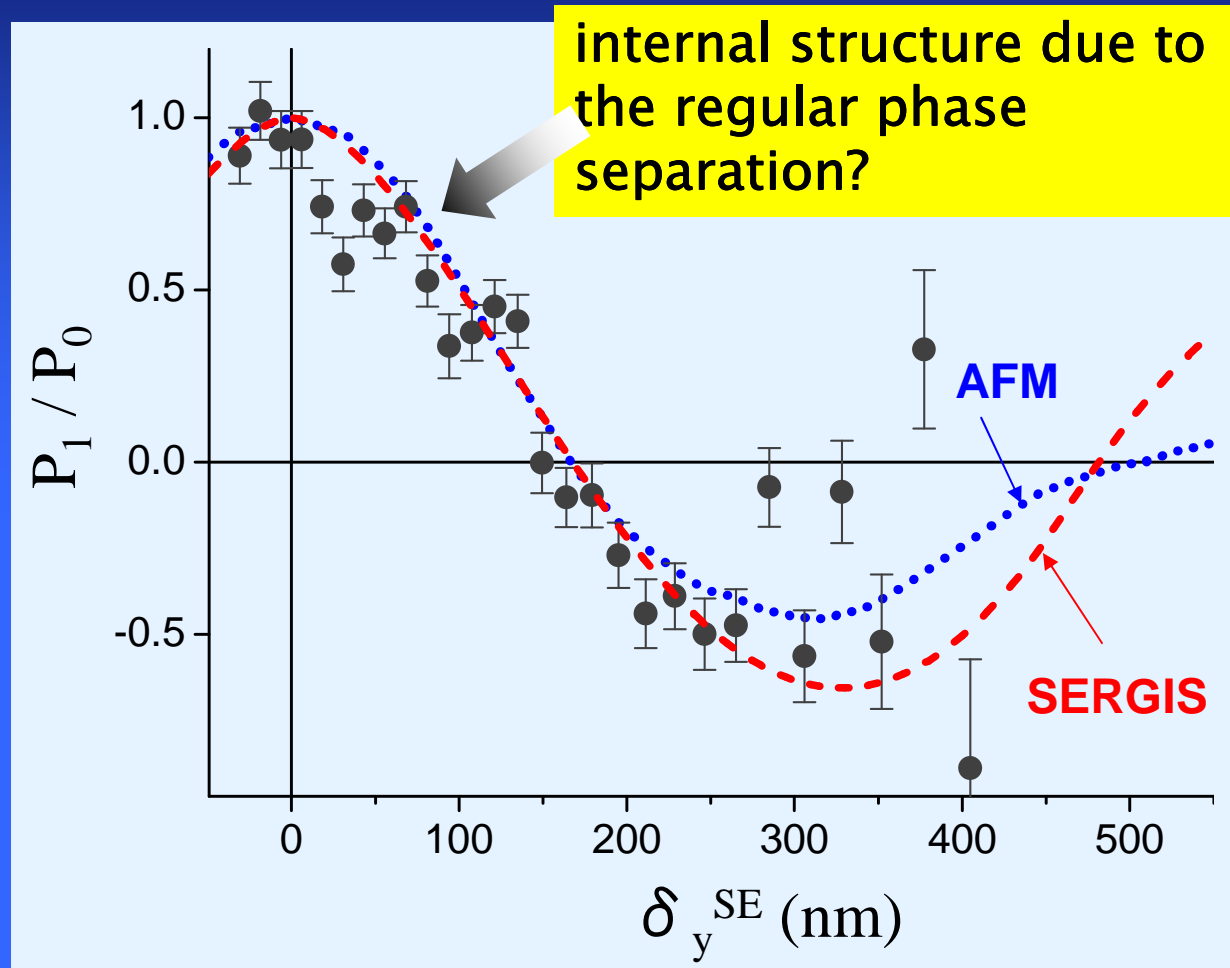


SERGIS
model:
 $R=170$ nm
 $H=20$ nm
 $D=480$ nm
 $\sigma = 50$ nm

AFM:
 $D=450$ nm

GISANS/GISAXS:
 $D=500$ nm

DIBLOCK COPOLYMER



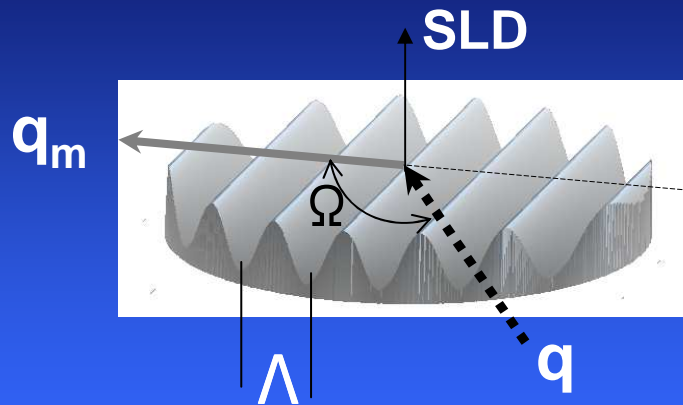
SERGIS
model:
R=230 nm
H=10 nm
D=600 nm
 $\sigma / D=0.17$

AFM:
D=630 nm

GISANS/GISAXS:
D=600 nm

AFM and GISAXS can not see internal structure,
GISANS can see and does see. What about SERGIS?

MODULATED DROPLETS



SLD contrast

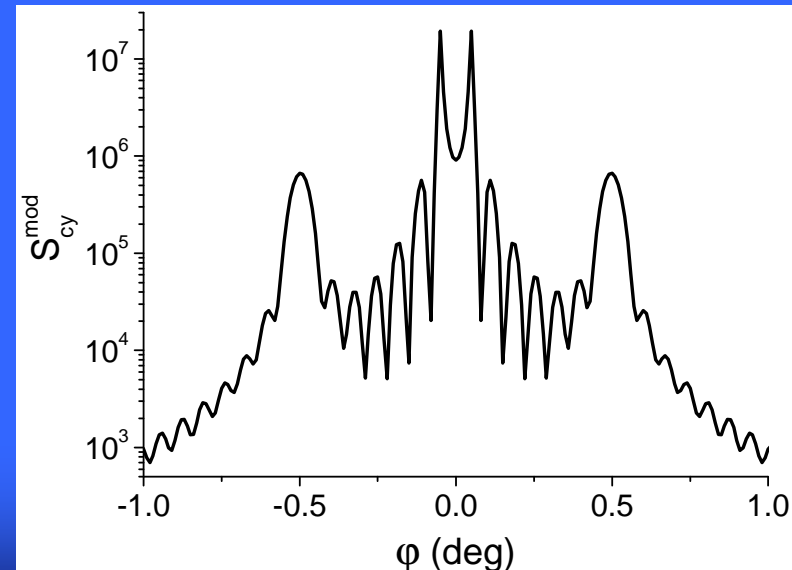
$$f_m(\mathbf{r}) = \bar{\rho} + \frac{\Delta\rho}{2} \cos(\mathbf{q}_m \cdot \mathbf{r})$$

mean SLD

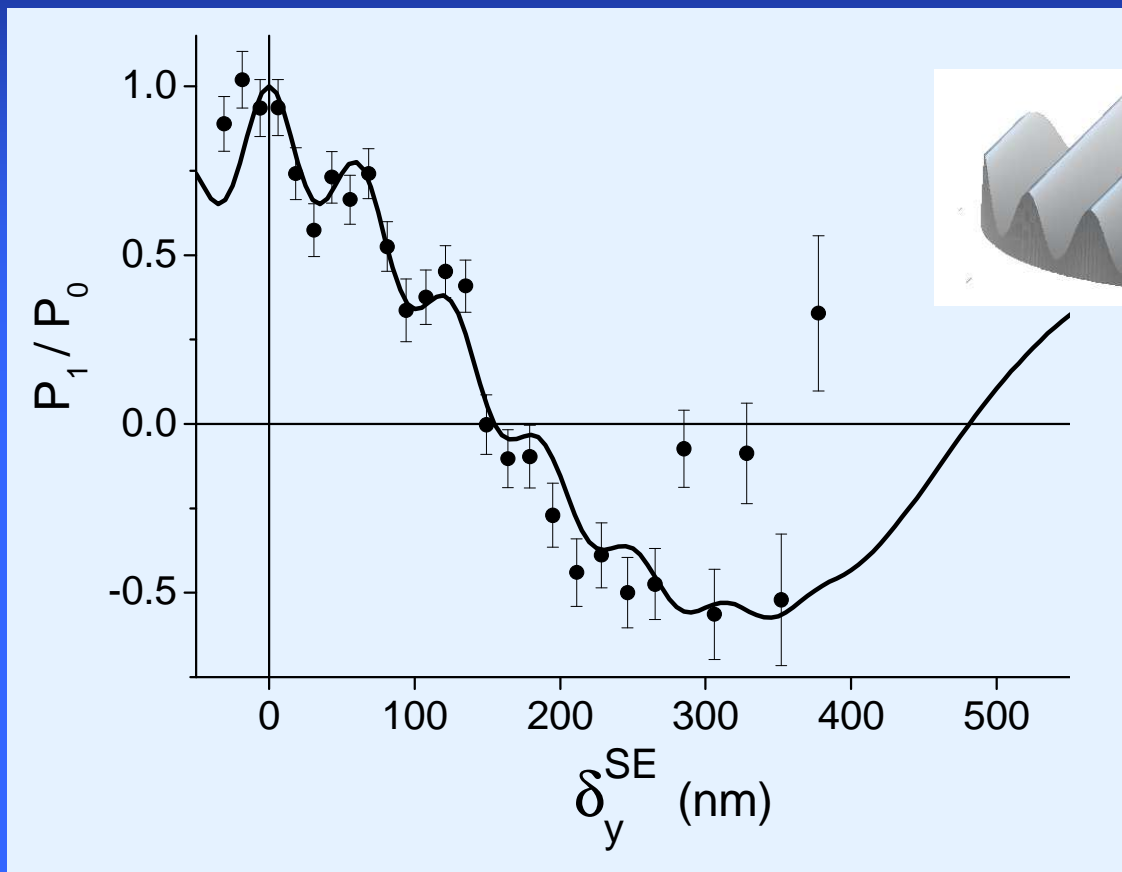
$$|F_{cy}^{\text{mod}}(\mathbf{q})| = \bar{\rho} |F_{cy}(\mathbf{q})| + \frac{\Delta\rho}{4} \left(\frac{J_1(|\mathbf{q}_{||} - \mathbf{q}_m|R)}{|\mathbf{q}_{||} - \mathbf{q}_m|R} + \frac{J_1(|\mathbf{q}_{||} + \mathbf{q}_m|R)}{|\mathbf{q}_{||} + \mathbf{q}_m|R} \right) \frac{\sin(q_z(\varphi, \alpha_f)H/2)}{q_z(\varphi, \alpha_f)H/2}$$

$$\overline{|F_{cy}^{\text{mod}}(\mathbf{q})|^2} = \frac{1}{\pi} \int_{-\pi/2}^{\pi/2} |F_{cy}^{\text{mod}}(\mathbf{q})|^2 d\Omega$$

$$S_{cy}^{\text{mod}}(\mathbf{q}) = c \overline{|F_{cy}^{\text{mod}}(\mathbf{q})|^2} I_H$$



DIBLOCK COPOLYMER – MODULATED DROPLETS



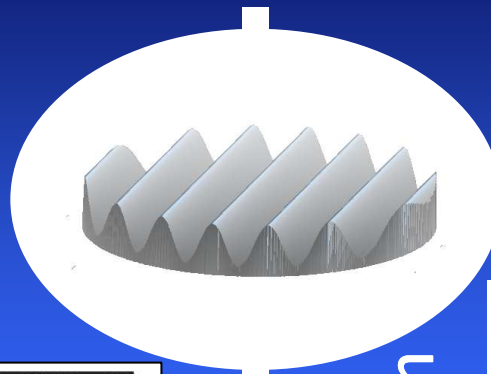
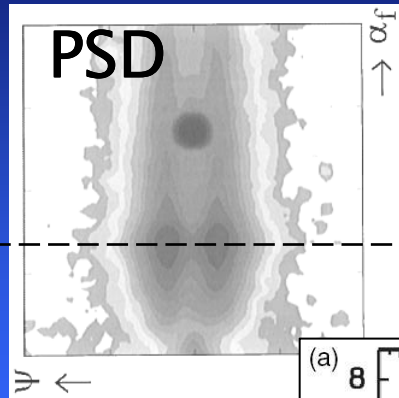
SERGIS
 $\Lambda = 64$ nm

GISANS:
 $\Lambda = 72$ nm

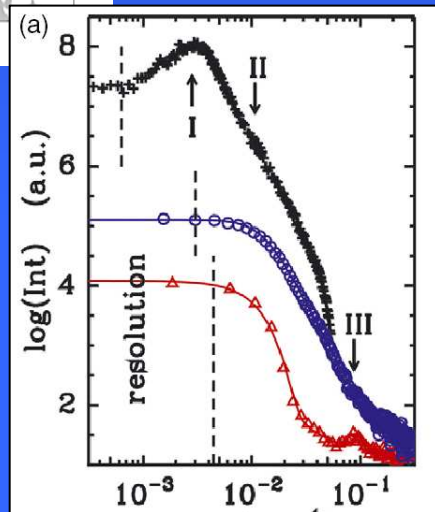
GISANS

vs.

SERGIS



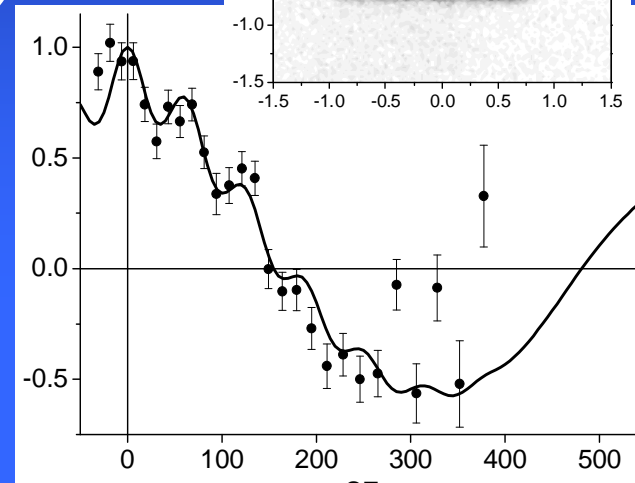
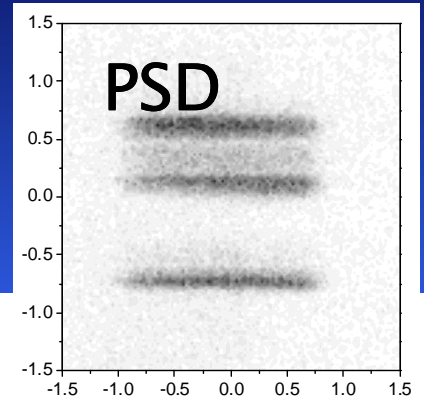
intensity



q_y (nm^{-1})

measuring time T_m :
8 hours at D22, ILL

polarization



T_m : 12 h at EVA

improvements:

monochromator $\Delta \lambda / \lambda$ 5%
improved polarization circuit
improved measuring algorithm
(one component, less points)

time factor:

12 h / 100 \approx 10 min /5
/2
/10

CONCLUSION

The SERGIS scattering technique can be especially advantageous for studying

- very soft,
- fragile,
- and liquid surfaces
- as well as buried interfaces

structured on length scales varying from nanometers to sub-micrometers.

Alternative techniques, such as AFM and SEM, cannot be applied for such kinds of objects.

Due to the grazing angle geometry, structural information about surfaces/interfaces can be obtained with adjustable depth resolution.

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